TEXAS INSTRUMENTS

LMV221

SNWS018D – DECEMBER 2006 – REVISED JUNE 2016

LMV221 50-MHz to 3.5-GHz 40-dB Logarithmic Power Detector for CDMA and WCDMA

1 Features

- 2.7-V to 3.3-V Supply Voltage
- 40-dB Linear in dB Power Detection Range
- 0.3-V to 2-V Output Voltage Range
- Shutdown
- Multi-Band Operation from 50 MHz to 3.5 GHz
- 0.5-dB Accurate Temperature Compensation
- External Configurable Output Filter Bandwidth
- 2.5 mm × 2.2 mm × 0.8 mm 6-pin WSON Package

2 Applications

- UMTS/CDMA/WCDMA RF Power Control
- GSM/GPRS RF Power Control
- PA Modules
- IEEE 802.11b, g (WLAN)

3 Description

The LMV221 is a 40-dB RF power detector intended for use in CDMA and WCDMA applications. The device has an RF frequency range from 50 MHz to 3.5 GHz. It provides an accurate temperature and supply-compensated output voltage that relates linearly to the RF input power in dBm. The circuit operates with a single supply from 2.7 V to 3.3 V.

The LMV221 has an RF power detection range from −45 dBm to −5 dBm and is ideally suited for direct use in combination with a 30-dB directional coupler. Additional low-pass filtering of the output signal can be achieved by means of an external resistor and capacitor. shows a detector with an additional output low pass filter. The filter frequency is set with R_S and C_S.

shows a detector with an additional feedback low pass filter. Resistor R_P is optional and lowers the trans-impedance gain (R_{TRANS}). The filter frequency is set with $C_P//C_{TRANS}$ and $R_P//R_{TRANS}$.

The device is active for Enable = High, otherwise it is in a low power consumption shutdown mode. To save power and prevent discharge of an external filter capacitance, the output (OUT) is high-impedance during shutdown.

Device Information[1]

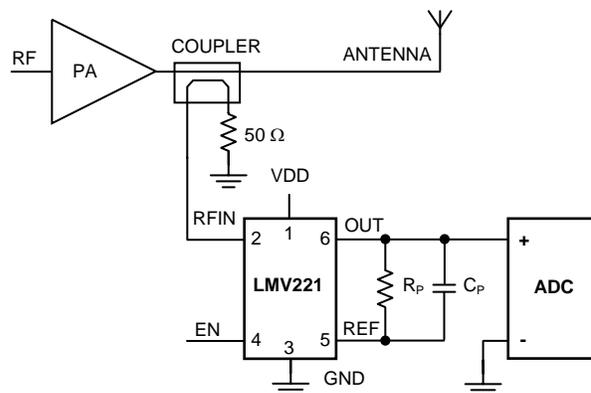| PART NUMBER	PACKAGE	BODY SIZE (NOM)
LMV221	WSON (6)	2.50 mm × 2.20 mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Typical Application: Output RC Low Pass Filter
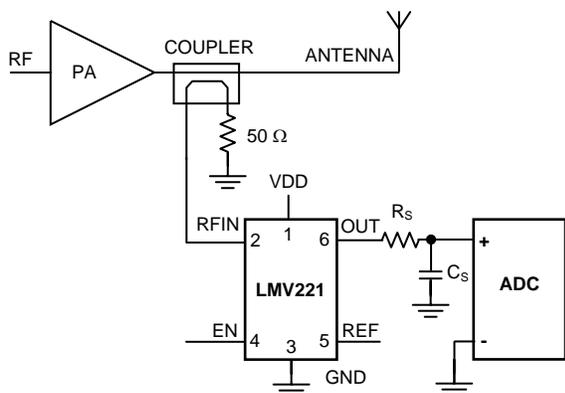
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Typical Application: Feedback (R)C Low Pass Filter

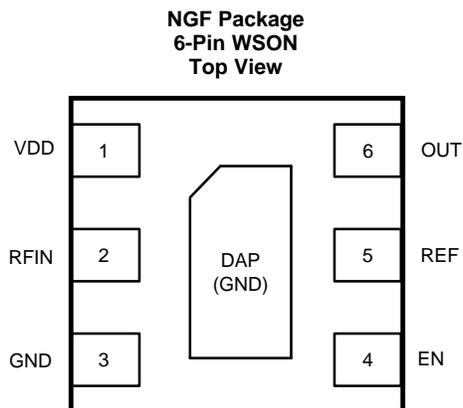Copyright © 2016, Texas Instruments Incorporated

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4 Revision History

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Changes from Revision B (March 2013) to Revision C   **Page**

5 Pin Configuration and Functions

NGF Package
6-Pin WSON
Top View

Pin Functions

PIN		TYPE	DESCRIPTION
NUMBER	NAME		
1	VDD	Power supply	Positive supply voltage
3	GND		Power ground
2	RFIN	Analog input	RF input signal to the detector, internally terminated with 50 Ω.
4	EN	Logic input	The device is enabled for EN = high, and brought to a low-power shutdown mode for EN = Low.
5	REF	Output	Reference output, for differential output measurement (without pedestal). Connected to inverting input of output amplifier.
6	OUT		Ground referenced detector output voltage (linear in dB)
DAP	GND	—	Ground (must be connected)

6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)[1]

		MIN	MAX	UNIT
SUPPLY VOLTAGE				
VDD - GND			3.6	V
RF INPUT				
Input power			10	dBm
DC voltage			400	mV
Enable input voltage		$V_{SS} - 0.4\ V < V_{EN} < V_{DD} + 0.4\ V$		
Junction temperature[2]			150	°C
Maximum lead temperature (soldering, 10 seconds)			260	°C
Storage temperature, T_{stg}		−65	150	°C

(1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
(2) The maximum power dissipation is a function of $T_{J(MAX)}$, $R_{\theta JA}$. The maximum allowable power dissipation at any ambient temperature is $P_D = (T_{J(MAX)} - T_A)/R_{\theta JA}$. All numbers apply for packages soldered directly into a PC board.

6.2 ESD Ratings

		VALUE	UNIT
$V_{(ESD)}$ Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001[1]	±2000	V
	Charged-device model (CDM), per JEDEC specification JESD22-C101[2]	±2000	
	Machine model	±200	

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

	MIN	NOM	MAX	UNIT
Supply voltage	2.7		3.3	V
Ambient temperature	−40		85	°C
RF frequency	50		3500	MHz
RF input power[1]	−45		−5	dBm
	−58		−18	dBV

(1) Power in dBV = dBm + 13 when the impedance is 50 Ω.

6.4 Thermal Information

	THERMAL METRIC[1]	LVM221 NGF (WSON) 6 PINS	UNIT
$R_{\theta JA}$	Junction-to-ambient thermal resistance[2]	100.4	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	120	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	7	°C/W
ψ_{JT}	Junction-to-top characterization parameter	69.6	°C/W
ψ_{JB}	Junction-to-board characterization parameter	6.9	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	69.9	°C/W

(1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics*, SPRA953.
(2) The maximum power dissipation is a function of $T_{J(MAX)}$, $R_{\theta JA}$. The maximum allowable power dissipation at any ambient temperature is $P_D = (T_{J(MAX)} - T_A)/R_{\theta JA}$. All numbers apply for packages soldered directly into a PC board.

6.5 2.7-V DC and AC Electrical Characteristics

Unless otherwise specified, all limits are ensured at T_A = 25°C, V_{DD} = 2.7 V, RF input frequency f = 1855-MHz continuous wave (CW), modulated. [1]

PARAMETER		TEST CONDITIONS	MIN[2]	TYP[3]	MAX[2]	UNIT
SUPPLY INTERFACE						
I_{DD}	Supply current	Active mode: EN = high, no signal present at RF_{IN}	6.5	7.2	8.5	mA
		Active mode: EN = high, no signal present at RF_{IN} T_A = −40°C to 85°C	5		10	
		Shutdown: EN = low, no signal present at RF_{IN}		0.5	3	µA
		Shutdown: EN = low, no signal present at RF_{IN} T_A = −40°C to 85°C			4	
		EN = Low: P_{IN} = 0 dBm[4] T_A = −40°C to 85°C			10	
LOGIC ENABLE INTERFACE						
V_{LOW}	EN logic low input level (shutdown mode)	T_A = −40°C to 85°C			0.6	V
V_{HIGH}	EN logic high input level	T_A = −40°C to 85°C	1.1			V
I_{EN}	Current into EN pin	T_A = −40°C to 85°C			1	µA
RF INPUT INTERFACE						
R_{IN}	Input resistance		40	47.1	60	Ω

(1) *2.7-V DC and AC Electrical Characteristics* values apply only for factory testing conditions at the temperature indicated. Factory testing conditions result in very limited self-heating of the device such that $T_J = T_A$. No specification of parametric performance is indicated in the electrical tables under conditions of internal self-heating where $T_J > T_A$.

(2) All limits are ensured by test or statistical analysis.

(3) Typical values represent the most likely parametric norm as determined at the time of characterization. Actual typical values may vary over time and also depend on the application and configuration. The typical values are not tested and are not specified on shipped production material.

(4) All limits are ensured by design and measurements which are performed on a limited number of samples. Limits represent the mean ±3–sigma values. The typical value represents the statistical mean value.

2.7-V DC and AC Electrical Characteristics (continued)

Unless otherwise specified, all limits are ensured at T_A = 25°C, V_{DD} = 2.7 V, RF input frequency f = 1855-MHz continuous wave (CW), modulated.[1]

PARAMETER		TEST CONDITIONS	MIN[2]	TYP[3]	MAX[2]	UNIT
OUTPUT INTERFACE						
V_{OUT}	Output voltage swing	From positive rail, sourcing, V_{REF} = 0 V, I_{OUT} = 1 mA		16	40	mV
		From positive rail, sourcing, V_{REF} = 0 V, I_{OUT} = 1 mA T_A = −40°C to 85°C			50	
		From negative rail, sinking, V_{REF} = 2.7 V, I_{OUT} = 1 mA		14	40	
		From negative rail, sinking, V_{REF} = 2.7 V, I_{OUT} = 1 mA T_A = −40°C to 85°C			50	
I_{OUT}	Output short circuit current	Sourcing, V_{REF} = 0 V, V_{OUT} = 2.6 V	3	5.4		mA
		Sourcing, V_{REF} = 0 V, V_{OUT} = 2.6 V T_A = −40°C to 85°C	2.7			
		Sinking, V_{REF} = 2.7 V, V_{OUT} = 0.1 V	3	5.7		
		Sinking, V_{REF} = 2.7 V, V_{OUT} = 0.1 V T_A = −40°C to 85°C	2.7			
BW	Small signal bandwidth	No RF input signal. Measured from REF input current to V_{OUT}		450		kHz
R_{TRANS}	Output amplifier transimpedance gain	No RF input signal, from I_{REF} to V_{OUT}, DC	35	42.7	55	kΩ
SR	Slew rate	Positive, V_{REF} from 2.7 V to 0 V	3	4.1		V/µs
		Positive, V_{REF} from 2.7 V to 0 V T_A = −40°C to 85°C	2.7			
		Negative, V_{REF} from 0 V to 2.7 V	3	4.2		
		Negative, V_{REF} from 0 V to 2.7 V T_A = −40°C to 85°C	2.7			
R_{OUT}	Output impedance[4]	No RF input signal, EN = High, DC measurement		0.6	5	Ω
		No RF input signal, EN = High, DC measurement T_A = −40°C to 85°C			6	
$I_{OUT,SD}$	Output leakage current in shutdown mode	EN = Low, V_{OUT} = 2 V		21	300	nA
		EN = Low, V_{OUT} = 2 V T_A = −40°C to 85°C			500	
RF DETECTOR TRANSFER						
$V_{OUT,MAX}$	Maximum output voltage[4]	f = 50 MHz, P_{IN} = −5 dBm		1.76		V
		f = 50 MHz, P_{IN} = −5 dBm T_A = −40°C to 85°	1.67		1.83	
		f = 900 MHz, P_{IN} = −5 dBm		1.75		
		f = 900 MHz, P_{IN} = −5 dBm T_A = −40°C to 85°C	1.67		1.82	
		f = 1855 MHz, P_{IN} = −5 dBm		1.61		
		f = 1855 MHz, P_{IN} = −5 dBm T_A = −40°C to 85°C	1.53		1.68	
		f = 2500 MHz, P_{IN} = −5 dBm		1.49		
		f = 2500 MHz, P_{IN} = −5 dBm T_A = −40°C to 85°C	1.42		1.57	
		f = 3000 MHz, P_{IN} = −5 dBm		1.4		
		f = 3000 MHz, P_{IN} = −5 dBm T_A = −40°C to 85°C	1.33		1.48	
		f = 3500 MHz, P_{IN} = −5 dBm		1.28		
		f = 3500 MHz, T_A = −40°C to 85°C	1.21		1.36	

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2.7-V DC and AC Electrical Characteristics (continued)

Unless otherwise specified, all limits are ensured at T_A = 25°C, V_{DD} = 2.7 V, RF input frequency f = 1855-MHz continuous wave (CW), modulated.[1]

PARAMETER		TEST CONDITIONS	MIN[2]	TYP[3]	MAX[2]	UNIT
$V_{OUT,MIN}$	Minimum output voltage (pedestal)	No input signal	175	250	350	mV
		No input signal, T_A = −40°C to 85°C	142		388	
	Pedestal variation over temperature	No input signal, relative to 25°C T_A = −40°C to 85°C	−20		20	
ΔV_{OUT}	Output voltage range[4]	f = 50 MHz, P_{IN} from −45 dBm to −5 dBm		1.44		V
		f = 50 MHz, P_{IN} from −45 dBm to −5 dBm T_A = −40°C to 85°C	1.37		1.52	
		f = 900 MHz, P_{IN} from −45 dBm to −5 dBm		1.4		
		f = 900 MHz, P_{IN} from −45 dBm to −5 dBm T_A = −40°C to 85°C	1.34		1.47	
		f = 1855 MHz, P_{IN} from −45 dBm to −5 dBm		1.3		
		f = 1855 MHz, P_{IN} from −45 dBm to −5 dBm T_A = −40°C to +85°C	1.24		1.37	
		f = 2500 MHz, P_{IN} from −45 dBm to −5 dBm		1.2		
		f = 2500 MHz, P_{IN} from −45 dBm to −5 dBm T_A = −40°C to 85°C	1.14		1.3	
		f = 3000 MHz, P_{IN} from −45 dBm to −5 dBm		1.12		
		f = 3000 MHz, P_{IN} from −45 dBm to −5 dBm T_A = −40°C to 85°C	1.07		1.2	
		f = 3500 MHz, P_{IN} from −45 dBm to −5 dBm		1.01		
		f = 3500 MHz, P_{IN} from −45 dBm to −5 dBm T_A = −40°C to 85°C	0.96		1.09	
K_{SLOPE}	Logarithmic slope[4]	f = 50 MHz	39	40.5	42	mV/dB
		f = 900 MHz	36.7	38.5	40	
		f = 1855 MHz	34.4	35.7	37.1	
		f = 2500 MHz	32.6	33.8	35.2	
		f = 3000 MHz	31	32.5	34	
		f = 3500 MHz	30	31.9	33.5	
P_{INT}	Logarithmic intercept[4]	f = 50 MHz	−50.4	−49.4	−48.3	dBm
		f = 900 MHz	−54.1	−52.8	−51.6	
		f = 1855 MHz	−53.2	−51.7	−50.2	
		f = 2500 MHz	−51.8	−50	−48.3	
		f = 3000 MHz	−51.1	−48.9	−46.6	
		f = 3500 MHz	−49.6	−46.8	−44.1	
e_n	Output referred noise[5]	P_{IN} = −10 dBm at 10 kHz		1.5		µV/√Hz
v_N	Output referred noise[4]	Integrated over frequency band, 1 kHz to 6.5 kHz		100		µV$_{RMS}$
		Integrated over frequency band, 1 kHz to 6.5 kHz T_A = −40°C to 85°C			150	
PSRR	Power supply rejection ratio[5]	P_{IN} = −10 dBm, f = 1800 MHz		60		dB
		P_{IN} = −10 dBm, f = 1800 MHz T_A = −40°C to 85°C	55			

(5) This parameter is ensured by design and/or characterization and is not tested in production.

2.7-V DC and AC Electrical Characteristics (continued)

Unless otherwise specified, all limits are ensured at T_A = 25°C, V_{DD} = 2.7 V, RF input frequency f = 1855-MHz continuous wave (CW), modulated.[1]

PARAMETER		TEST CONDITIONS	MIN[2]	TYP[3]	MAX[2]	UNIT
POWER MEASUREMENT PERFORMANCE						
E_{LC}	Log conformance error[4]	f = 50 MHz −40 dBm ≤ P_{IN} ≤ −10 dBm	−0.6		0.56	dB
		f = 50 MHz, T_A = −40°C to 85°C −40 dBm ≤ P_{IN} ≤ −10 dBm	−1.1	0.53	1.3	
		f = 900 MHz −40 dBm ≤ P_{IN} ≤ −10 dBm	−0.7		0.37	
		f = 900 MHz, T_A = −40°C to 85°C −40 dBm ≤ P_{IN} ≤ −10 dBm	−1.24	0.46	1.1	
		f = 1855 MHz −40 dBm ≤ P_{IN} ≤ −10 dBm	−0.4		0.24	
		f = 1855 MHz, T_A = −40°C to 85°C −40 dBm ≤ P_{IN} ≤ −10 dBm	−1.1	0.48	1.1	
		f = 2500 MHz −40 dBm ≤ P_{IN} ≤ −10 dBm	−0.43		0.56	
		f = 2500 MHz, T_A = −40°C to 85°C −40 dBm ≤ P_{IN} ≤ −10 dBm	−1	0.51	1.1	
		f = 3000 MHz −40 dBm ≤ P_{IN} ≤ −10 dBm	−0.87		1.34	
		f = 3000 MHz, T_A = −40°C to 85°C −40 dBm ≤ P_{IN} ≤ −10 dBm	−1.2	0.56	1.6	
		f = 3500 MHz −40 dBm ≤ P_{IN} ≤ −10 dBm	−1.73		2.72	
		f = 3500 MHz, T_A = −40°C to 85°C	−2	0.84	2.7	
E_{VOT}	Variation over temperature[4]	f = 50 MHz, T_A = −40°C to 85°C −40 dBm ≤ P_{IN} ≤ −10 dBm	−1.1	0.4	1.4	dB
		f = 900 MHz, T_A = −40°C to 85°C −40 dBm ≤ P_{IN} ≤ −10 dBm	−1	0.38	1.27	
		f = 1855 MHz, T_A = −40°C to 85°C −40 dBm ≤ P_{IN} ≤ −10 dBm	−1.1	0.44	1.31	
		f = 2500 MHz, T_A = −40°C to 85°C −40 dBm ≤ P_{IN} ≤ −10 dBm	−1.1	0.48	1.15	
		f = 3000 MHz, T_A = −40°C to 85°C −40 dBm ≤ P_{IN} ≤ −10 dBm	−1.2	0.5	0.98	
		f = 3500 MHz, T_A = −40°C to 85°C −40 dBm ≤ P_{IN} ≤ −10 dBm	−1.2	0.62	0.85	
$E_{1\,dB}$	Measurement error for a 1-dB Input power step[4]	f = 50 MHz, T_A = −40°C to 85°C −40 dBm ≤ P_{IN} ≤ −10 dBm	−0.06		0.069	dB
		f = 900 MHz, T_A = −40°C to 85°C −40 dBm ≤ P_{IN} ≤ −10 dBm	−0.056		0.056	
		f = 1855 MHz, T_A = −40°C to 85°C −40 dBm ≤ P_{IN} ≤ −10 dBm	−0.069		0.069	
		f = 2500 MHz, T_A = −40°C to 85°C −40 dBm ≤ P_{IN} ≤ −10 dBm	−0.084		0.084	
		f = 3000 MHz, T_A = −40°C to 85°C −40 dBm ≤ P_{IN} ≤ −10 dBm	−0.092		0.092	
		f = 3500 MHz, T_A = −40°C to 85°C −40 dBm ≤ P_{IN} ≤ −10 dBm	−0.1		0.1	

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2.7-V DC and AC Electrical Characteristics (continued)

Unless otherwise specified, all limits are ensured at T_A = 25°C, V_{DD} = 2.7 V, RF input frequency f = 1855-MHz continuous wave (CW), modulated.[1]

PARAMETER		TEST CONDITIONS	MIN[2]	TYP[3]	MAX[2]	UNIT
$E_{10\ dB}$	Measurement Error for a 10-dB Input power step [4]	f = 50 MHz, T_A = –40°C to 85°C, –40 dBm ≤ P_{IN} ≤ –10 dBm	–0.65		0.57	dB
		f = 900 MHz, T_A = –40°C to 85°C, –40 dBm ≤ P_{IN} ≤ –10 dBm	–0.75		0.58	
		f = 1855 MHz, T_A = –40°C to 85°C, –40 dBm ≤ P_{IN} ≤ –10 dBm	–0.88		0.72	
		f = 2500 MHz, T_A = –40°C to 85°C, –40 dBm ≤ P_{IN} ≤ –10 dBm	–0.86		0.75	
		f = 3000 MHz, T_A = –40°C to 85°C, –40 dBm ≤ P_{IN} ≤ –10 dBm	–0.85		0.77	
		f = 3500 MHz, T_A = –40°C to 85°C, –40 dBm ≤ P_{IN} ≤ –10 dBm	–0.76		0.74	
S_T	Temperature sensitivity	f = 50 MHz, –40 dBm ≤ P_{IN} ≤ –10 dBm		–7		mdB/°C
		f = 50 MHz, –40°C < T_A < 25°C [4]	–15		1	
		f = 900 MHz, –40 dBm ≤ P_{IN} ≤ –10 dBm		–6		
		f = 900 MHz, –40°C < T_A < 25°C, –40 dBm ≤ P_{IN} ≤ –10 dBm [4]	–13.4		1.5	
		f = 1855 MHz, –40 dBm ≤ P_{IN} ≤ –10 dBm		–5.9		
		f = 1855 MHz, –40°C < T_A < 25°C, –40 dBm ≤ P_{IN} ≤ –10 dBm [4]	–14.1		2.3	
		f = 2500 MHz, –40 dBm ≤ P_{IN} ≤ –10 dBm		–4.1		
		f = 2500 MHz, –40°C < T_A < 25°C, –40 dBm ≤ P_{IN} ≤ –10 dBm [4]	–13.4		5.2	
		f = 3000 MHz, –40 dBm ≤ P_{IN} ≤ –10 dBm		–1.8		
		f = 3000 MHz, –40°C < T_A < 25°C, –40 dBm ≤ P_{IN} ≤ –10 dBm [4]	–11.7		8	
		f = 3500 MHz, –40 dBm ≤ P_{IN} ≤ –10 dBm		0.5		
		f = 3500 MHz, –40°C < T_A < 25°C, –40 dBm ≤ P_{IN} ≤ –10 dBm [4]	–10.5		1.2	
S_T	Temperature sensitivity	f = 50 MHz, –40 dBm ≤ P_{IN} ≤ –10 dBm		–6.7		mdB/°C
		f = 50 MHz, 25°C < T_A < 85°C, –40 dBm ≤ P_{IN} ≤ –10 dBm [4]	–12.3		–1.1	
		f = 900 MHz, –40 dBm ≤ P_{IN} ≤ –10 dBm		–6.7		
		f = 900 MHz, 25°C < T_A < 85°C, –40 dBm ≤ P_{IN} ≤ –10 dBm [4]	–13.1		–0.2	
		f = 1855 MHz, –40 dBm ≤ P_{IN} ≤ –10 dBm		–7.1		
		f = 1855 MHz, 25°C < T_A < 85°C, –40 dBm ≤ P_{IN} ≤ –10 dBm [4]	–14.7		0.42	
		f = 2500 MHz, –40 dBm ≤ P_{IN} ≤ –10 dBm		–7.6		
		f = 2500 MHz, 25°C < T_A < 85°C, –40 dBm ≤ P_{IN} ≤ –10 dBm [4]	–15.9		0.63	
		f = 3000 MHz, –40 dBm ≤ P_{IN} ≤ –10 dBm		–8.5		
		f = 3000 MHz, 25°C < T_A < 85°C, –40 dBm ≤ P_{IN} ≤ –10 dBm [4]	–18		1	
		f = 3500 MHz, –40 dBm ≤ P_{IN} ≤ –10 dBm		–9.5		
		f = 3500 MHz, 25°C < T_A < 85°C, –40 dBm ≤ P_{IN} ≤ –10 dBm [4]	–21.2		2.5	

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2.7-V DC and AC Electrical Characteristics (continued)

Unless otherwise specified, all limits are ensured at T_A = 25°C, V_{DD} = 2.7 V, RF input frequency f = 1855-MHz continuous wave (CW), modulated.[1]

PARAMETER		TEST CONDITIONS	MIN[2]	TYP[3]	MAX[2]	UNIT
S_T	Temperature sensitivity[4]	f = 50 MHz, P_{IN} = −10 dBm		−8.3		mdB/°C
		f = 50 MHz, −40°C < T_A < 25°C P_{IN} = −10 dBm[4]	−15.8		−0.75	
		f = 900 MHz, P_{IN} = −10 dBm		−6		
		f = 900 MHz, −40°C < T_A < 25°C P_{IN} = −10 dBm[4]	−14.2		2.2	
		f = 1855 MHz, P_{IN} = −10 dBm		−7.4		
		f = 1855 MHz, −40°C < T_A < 25°C P_{IN} = −10 dBm[4]	−14.9		2	
		f = 2500 MHz, P_{IN} = −10 dBm		−6.6		
		f = 2500 MHz, −40°C < T_A < 25°C P_{IN} = −10 dBm[4]	−14.5		1.3	
		f = 3000 MHz, P_{IN} = −10 dBm		−4.9		
		f = 3000 MHz, −40°C < T_A < 25°C P_{IN} = −10 dBm[4]	−13		3.3	
		f = 3500 MHz, P_{IN} = −10 dBm		−3.4		
		f = 3500 MHz, −40°C < T_A < 25°C P_{IN} = −10 dBm[4]	−12		5.3	
S_T	Temperature sensitivity[4]	f = 50 MHz, P_{IN} = −10 dBm		−8.9		mdB/°C
		f = 50 MHz, 25°C < T_A < 85°C P_{IN} = −10 dBm[4]	−12.4		−5.3	
		f = 900 MHz, P_{IN} = −10 dBm		−9.4		
		f = 900 MHz, 25°C < T_A < 85°C P_{IN} = −10 dBm[4]	−13.7		−5	
		f = 1855 MHz, P_{IN} = −10 dBm		−10		
		f = 1855 MHz, 25°C < T_A < 85°C P_{IN} = −10 dBm[4]	−14.6		−5.6	
		f = 2500 MHz, P_{IN} = −10 dBm		−10.8		
		f = 2500 MHz, 25°C < T_A < 85°C P_{IN} = −10 dBm[4]	−15.2		−6.5	
		f = 3000 MHz, P_{IN} = −10 dBm		−12.2		
		f = 3000 MHz, 25°C < T_A < 85°C P_{IN} = −10 dBm[4]	−16.5		−7.9	
		f = 3500 MHz, P_{IN} = −10 dBm		−13.5		
		f = 3500 MHz, 25°C < T_A < 85°C P_{IN} = −10 dBm[4]	−18.1		−9	
P_{MAX}	Maximum input power for E_{LC} = 1 dB[4]	f = 50 MHz		−5.9		dBm
		f = 50 MHz, T_A = −40°C to 85°C	−8.85			
		f = 900 MHz		−6.1		
		f = 900 MHz, MIN at T_A = −40°C to 85°C	−9.3			
		f = 1855 MHz		−5.5		
		f = 1855 MHz, T_A = −40°C to 85°C	−8.3			
		f = 2500 MHz		−4.2		
		f = 2500 MHz, T_A = −40°C to 85°C	−6			
		f = 3000 MHz		−3.7		
		f = 3000 MHz, T_A = −40°C to 85°C	−5.4			
		f = 3500 MHz		−2.7		
		f = 3500 MHz, T_A = −40°C to 85°C	−7.2			

Product Folder Links: *LMV221*

2.7-V DC and AC Electrical Characteristics (continued)

Unless otherwise specified, all limits are ensured at T_A = 25°C, V_{DD} = 2.7 V, RF input frequency f = 1855-MHz continuous wave (CW), modulated.[1]

PARAMETER		TEST CONDITIONS	MIN[2]	TYP[3]	MAX[2]	UNIT
P_{MIN}	Minimum input power for E_{LC} = 1 dB[4]	f = 50 MHz		−40.3		dBm
		f = 50 MHz, T_A = −40°C to 85°C			−38.9	
		f = 900 MHz		−44.2		
		f = 900 MHz, MIN at T_A = −40°C to 85°C			−42.9	
		f = 1855 MHz		−42.9		
		f = 1855 MHz, T_A = −40°C to 85°C			−41.2	
		f = 2500 MHz		−40.4		
		f = 2500 MHz, T_A = −40°C to 85°C			−38.6	
		f = 3000 MHz		−38.4		
		f = 3000 MHz, T_A = −40°C to 85°C			−35.8	
		f = 3500 MHz		−35.3		
		f = 3500 MHz, T_A = −40°C to 85°C			−31.9	
DR	Dynamic range for E_{LC} = 1 dB[4]	f = 50 MHz		34.5		dB
		f = 50 MHz, T_A = −40°C to 85°C	31.5			
		f = 900 MHz		38.1		
		f = 900 MHz, MIN at T_A = −40°C to 85°C	34.4			
		f = 1855 MHz		37.4		
		f = 1855 MHz, T_A = −40°C to 85°C	34			
		f = 2500 MHz		36.1		
		f = 2500 MHz, T_A = −40°C to 85°C	33.8			
		f = 3000 MHz		34.8		
		f = 3000 MHz, T_A = −40°C to 85°C	32.4			
		f = 3500 MHz		32.7		
		f = 3500 MHz, T_A = −40°C to 85°C	26.2			

6.6 Timing Requirements

		MIN	NOM	MAX	UNIT
t_{ON}	Turnon time, no signal at P_{IN}, low-high transition EN, V_{OUT} to 90%[1]		8	10	µs
	Turnon time, no signal at P_{IN}, low-high transition EN, V_{OUT} to 90%[1] T_A = −40°C to 85°C			12	
t_R	Rise time[2], P_{IN} = no signal to 0 dBm, V_{OUT} from 10% to 90%		2		µs
	Rise time[2], P_{IN} = no signal to 0 dBm, V_{OUT} from 10% to 90% T_A = −40°C to 85°C			12	
t_F	Fall time[2], P_{IN} = no signal to 0 dBm, V_{OUT} from 90% to 10%		2		µs
	Fall time[2], P_{IN} = no signal to 0 dBm, V_{OUT} from 90% to 10% T_A = −40°C to 85°C			12	

(1) All limits are ensured by design and measurements, which are performed on a limited number of samples. Limits represent the mean ±3-sigma values. The typical value represents the statistical mean value.
(2) This parameter is ensured by design and/or characterization and is not tested in production.

Product Folder Links: *LMV221*

6.7 Typical Characteristics

Unless otherwise specified, V_{DD} = 2.7V, T_A = 25°C, measured on a limited number of samples.
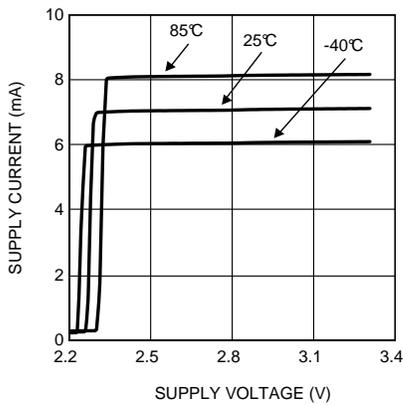

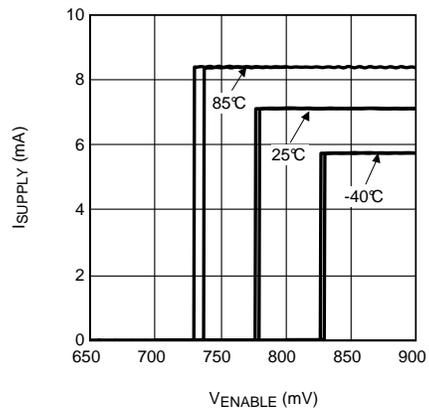Figure 1. Supply Current vs Supply Voltage

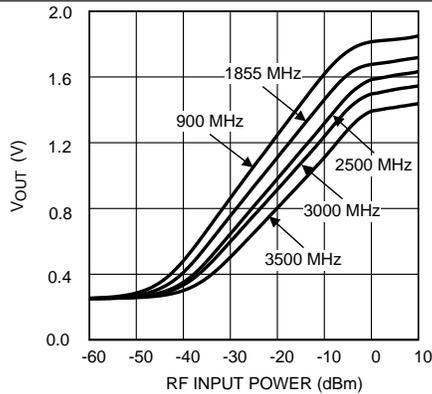

Figure 2. Supply Current vs Enable Voltage

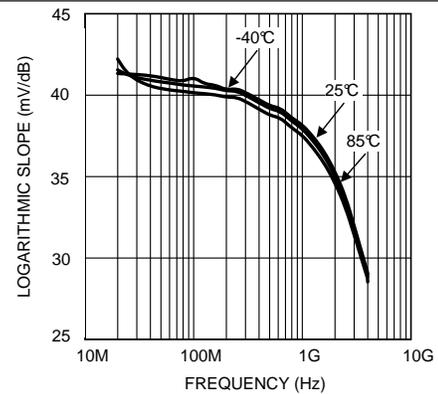Figure 3. Output Voltage vs RF Input Power
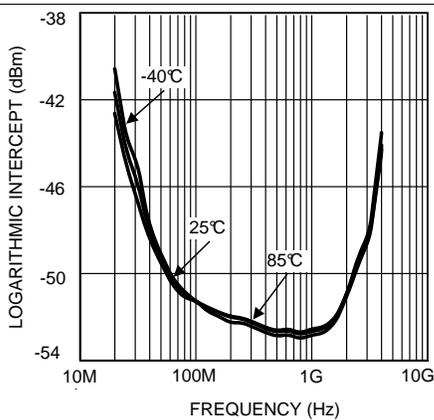

Figure 4. Log Slope vs Frequency

Figure 5. Log Intercept vs Frequency

Figure 6. Output Voltage vs Frequency
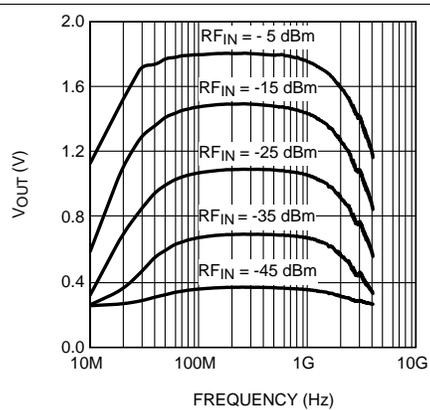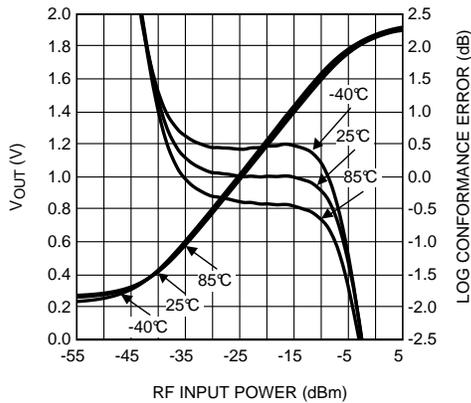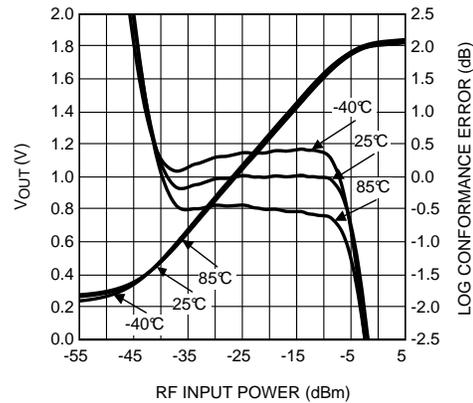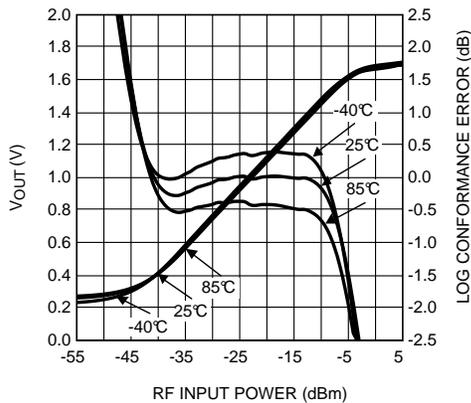
Product Folder Links: *LMV221*

Typical Characteristics (continued)

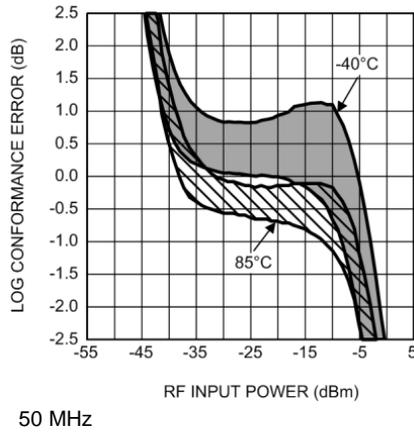Unless otherwise specified, V_{DD} = 2.7V, T_A = 25°C, measured on a limited number of samples.

50 MHz

Figure 7. Mean Output Voltage and Log Conformance Error vs RF Input Power

900 MHz

Figure 8. Mean Output Voltage and Log Conformance Error vs RF Input Power

1855 MHz

Figure 9. Mean Output Voltage and Log Conformance Error vs RF Input Power
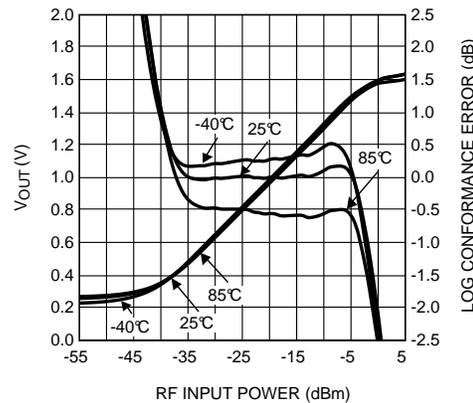
2500 MHz

Figure 10. Mean Output Voltage and Log Conformance Error vs RF Input Power
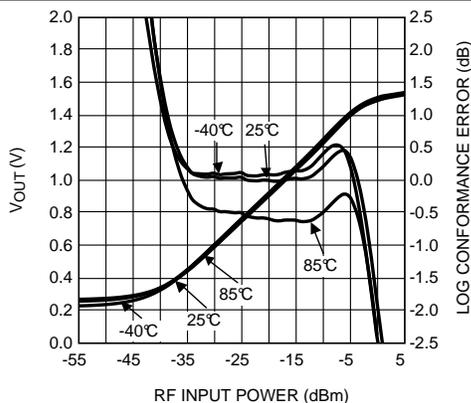
3000 MHz

Figure 11. Mean Output Voltage and Log Conformance Error vs RF Input Power
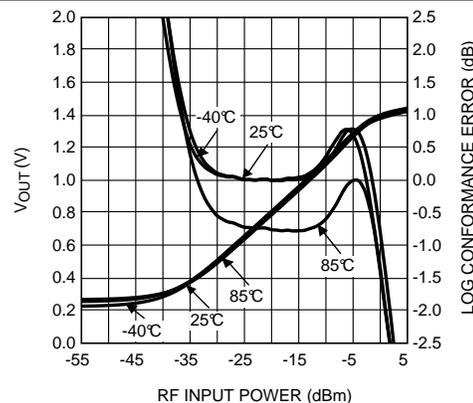
3500 MHz

Figure 12. Mean Output Voltage and Log Conformance Error vs RF Input Power

Typical Characteristics (continued)

Unless otherwise specified, V_{DD} = 2.7V, T_A = 25°C, measured on a limited number of samples.

50 MHz

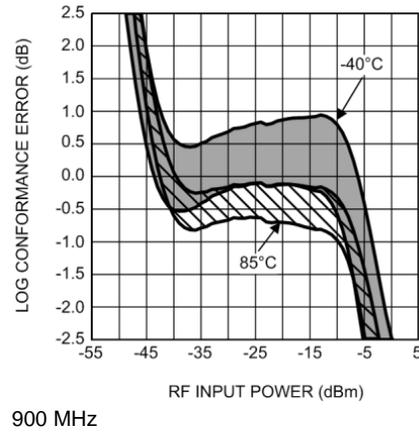**Figure 13. Log Conformance Error (Mean ±3 Sigma) vs RF Input Power**

900 MHz

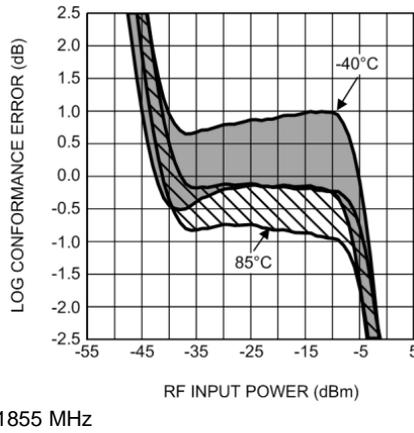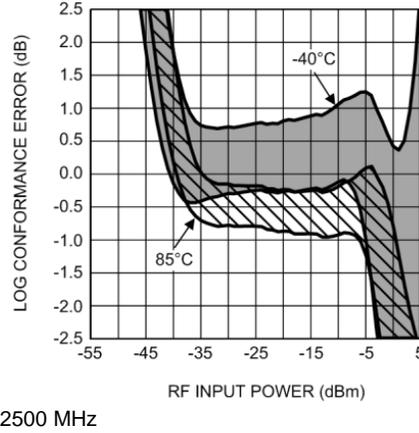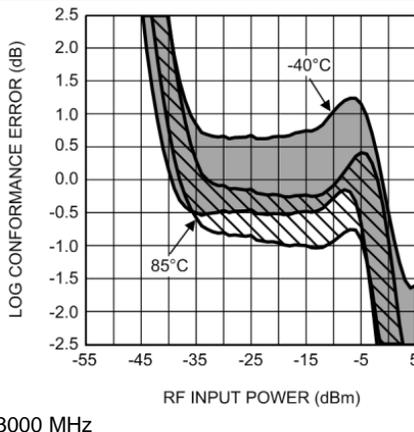**Figure 14. Log Conformance Error (Mean ±3 Sigma) vs RF Input Powert**

1855 MHz

Figure 15. Log Conformance Error (Mean ±3 Sigma) vs RF Input Power

2500 MHz

Figure 16. Log Conformance Error (Mean ±3 Sigma) vs RF Input Power

3000 MHz

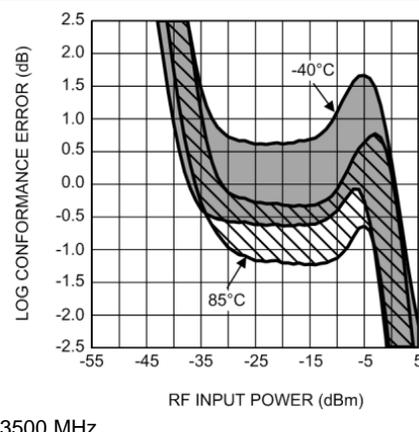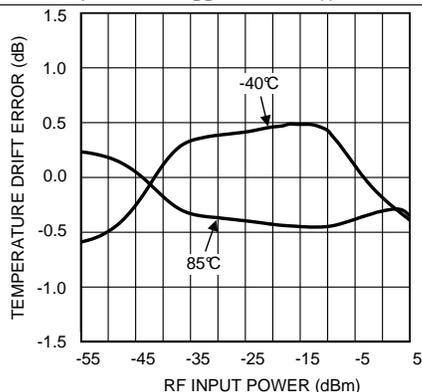**Figure 17. Log Conformance Error (Mean ±3 Sigma) vs RF Input Power**

3500 MHz

Figure 18. Log Conformance Error (Mean ±3 Sigma) vs RF Input Power
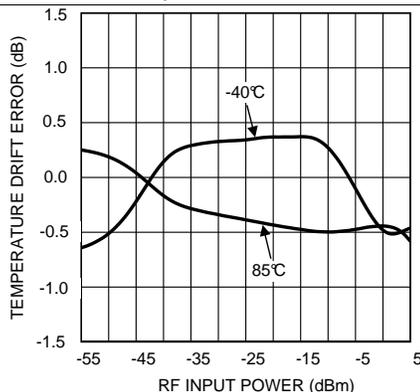
Product Folder Links: *LMV221*

Typical Characteristics (continued)

Unless otherwise specified, V_{DD} = 2.7V, T_A = 25°C, measured on a limited number of samples.
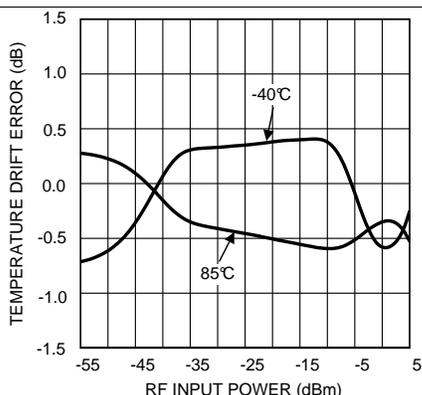
50 MHz

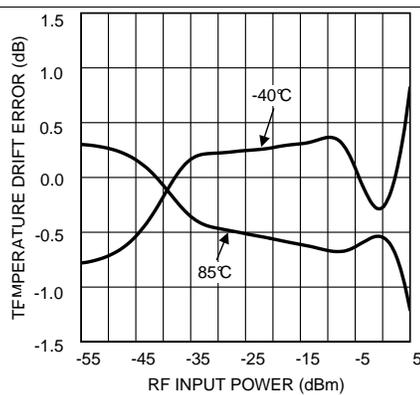**Figure 19. Mean Temperature Drift Error vs Rf Input Power At 50 MHz**

900 MHz

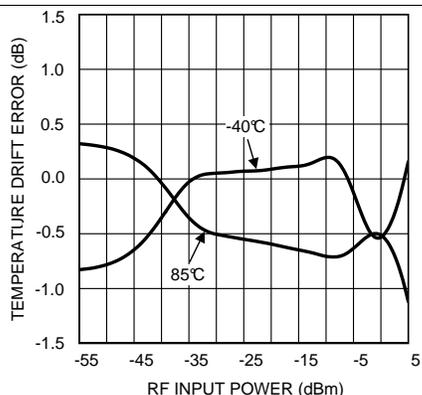**Figure 20. Mean Temperature Drift Error vs RF Input Power**

1855 MHz

Figure 21. Mean Temperature Drift Error vs RF Input Power
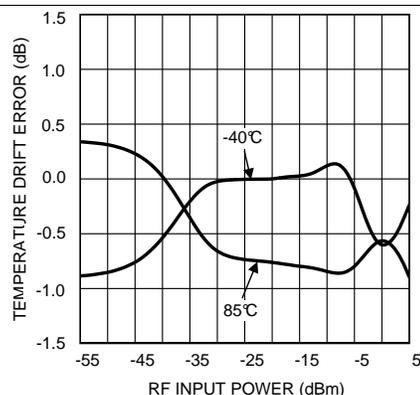
2500 MHz

Figure 22. Mean Temperature Drift Error vs RF Input Powert

3000 MHz

Figure 23. Mean Temperature Drift Error vs RF Input Power

3500 MHz

Figure 24. Mean Temperature Drift Error vs RF Input Power

Typical Characteristics (continued)

Unless otherwise specified, V_{DD} = 2.7V, T_A = 25°C, measured on a limited number of samples.

50 MHz

Figure 25. Temperature Drift Error (Mean ±3 Sigma) vs RF Input Power

900 MHz

Figure 26. Temperature Drift Error (Mean ±3 Sigma) vs RF Input Power

1855 MHz

Figure 27. Temperature Drift Error (Mean ±3 Sigma) vs RF Input Power

2500 MHz
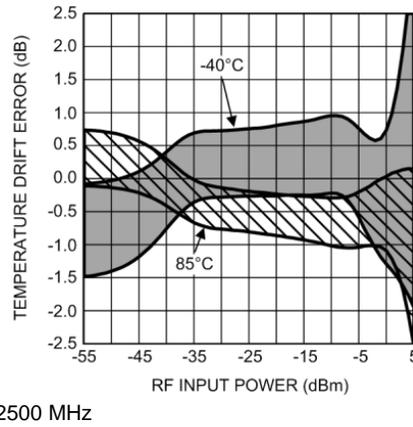
Figure 28. Temperature Drift Error (Mean ±3 Sigma) vs RF Input Power

3000 MHz
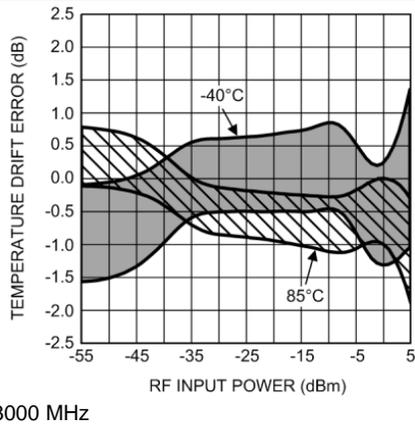
Figure 29. Temperature Drift Error (Mean ±3 Sigma) vs RF Input Power

3500 MHz
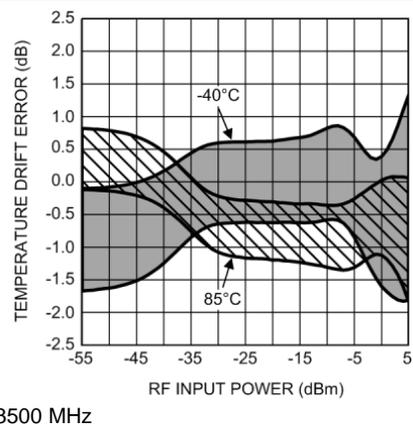
Figure 30. Temperature Drift Error (Mean ±3 Sigma) vs RF Input Power

Typical Characteristics (continued)

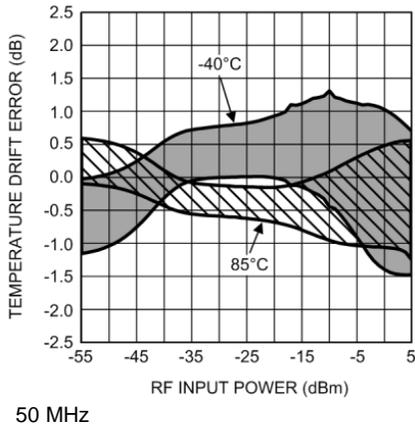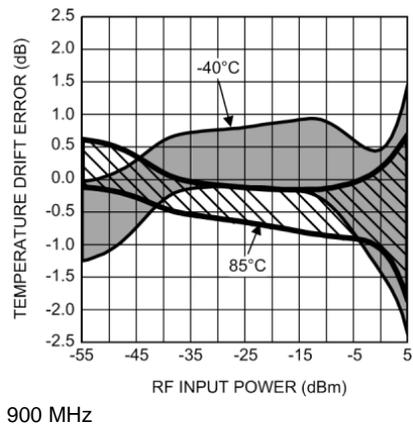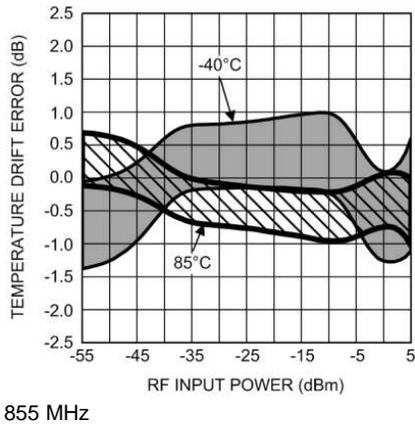Unless otherwise specified, V_{DD} = 2.7V, T_A = 25°C, measured on a limited number of samples.
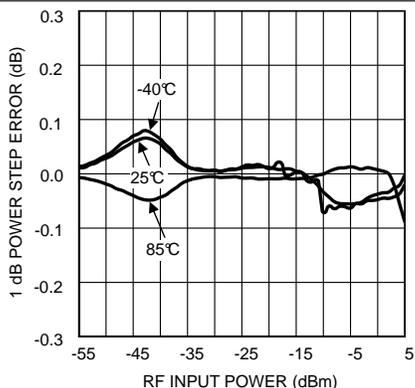
50 MHz

Figure 31. Error For 1-dB Input Power Step vs RF Input Power
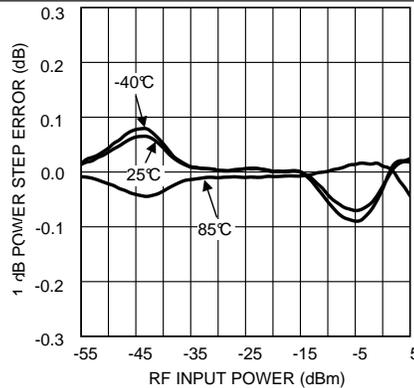
900 MHz

Figure 32. Error For 1-dB Input Power Step vs RF Input Power
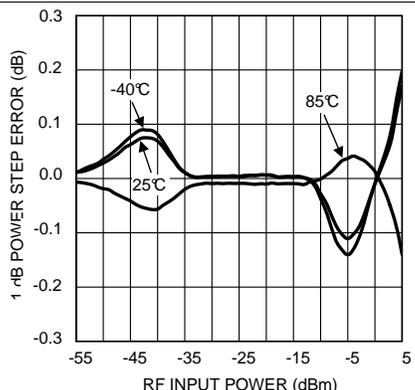
1855 MHz

Figure 33. Error For 1-dB Input Power Step vs RF Input Power
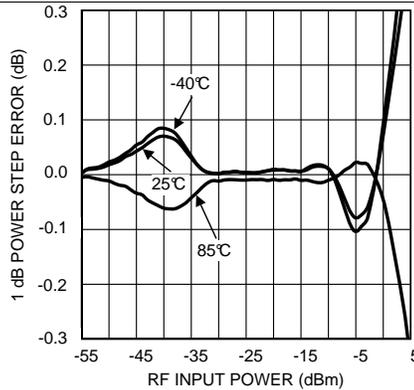
2500 MHz

Figure 34. Error For 1-dB Input Power Step vs RF Input Power
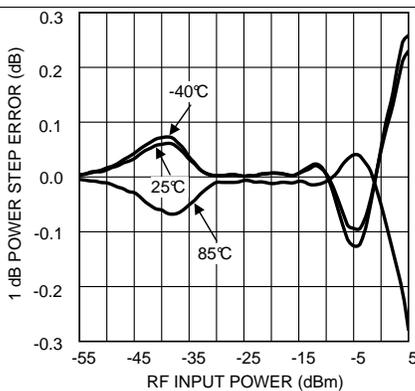
3000 MHz

Figure 35. Error For 1-dB Input Power Step vs RFInput Power
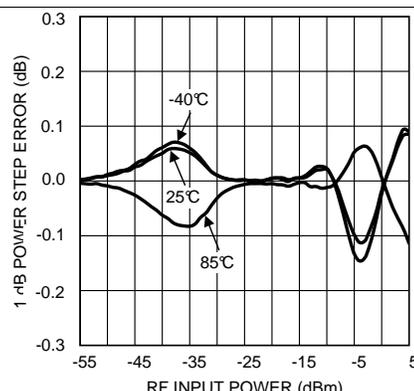
3500 MHz

Figure 36. Error For 1-dB Input Power Step vs RF Input Power

Product Folder Links: *LMV221*

Typical Characteristics (continued)

Unless otherwise specified, V_{DD} = 2.7V, T_A = 25°C, measured on a limited number of samples.

50 MHz
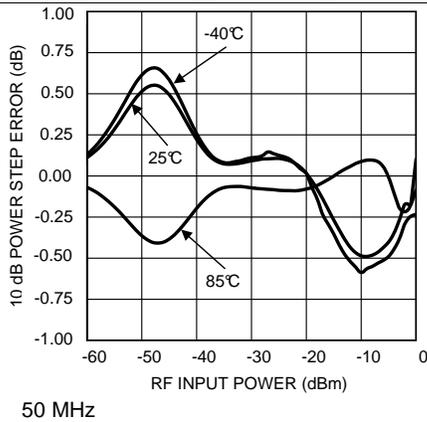
Figure 37. Error For 10-dB Input Power Step vs RF Input Power

900 MHz
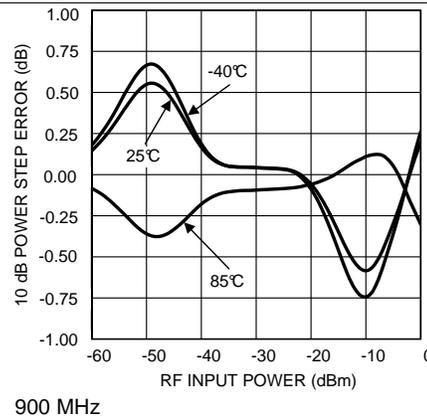
Figure 38. Error For 10-dB Input Power Step vs RF Input Power

1855 MHz
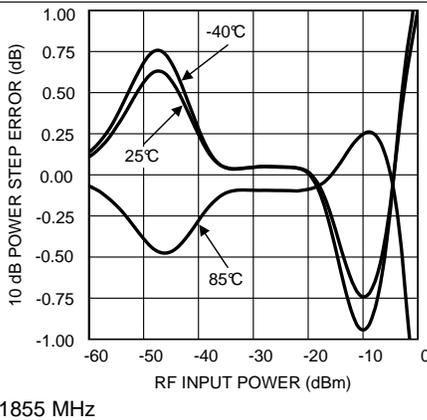
Figure 39. Error For 10-dB Input Power Step vs RF Input Power

2500 MHz
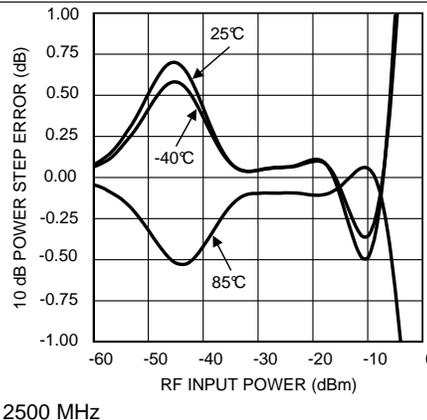
Figure 40. Error For 10-dB Input Power Step vs RF Input Power

3000 MHz
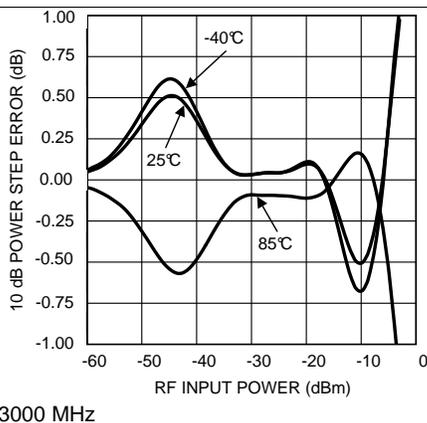
Figure 41. Error For 10-dB Input Power Step vs RF Input Power

3500 MHz
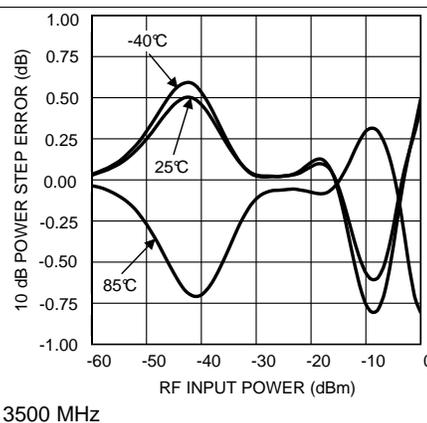
Figure 42. Error For 10-dB Input Power Step vs RF Input Power

Product Folder Links: *LMV221*

Typical Characteristics (continued)

Unless otherwise specified, V_{DD} = 2.7V, T_A = 25°C, measured on a limited number of samples.
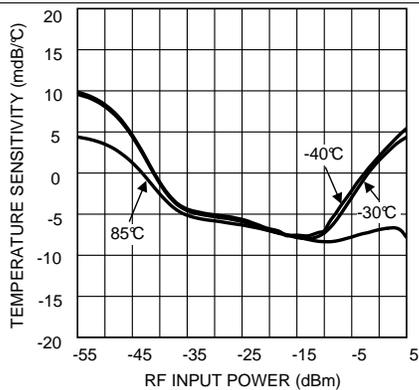
50 MHz

Figure 43. Mean Temperature Sensitivity vs RF Input Power
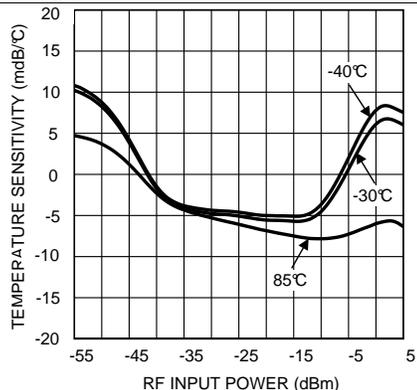
900 MHz

Figure 44. Mean Temperature Sensitivity vs RF Input Power
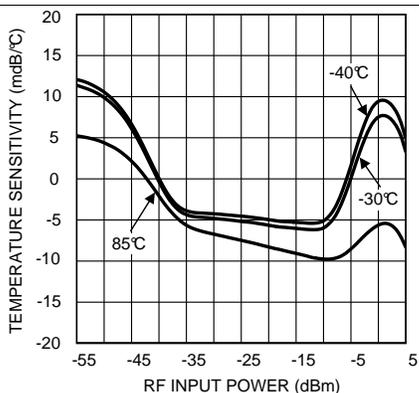
1855 MHz

Figure 45. Mean Temperature Sensitivity vs RF Input Power
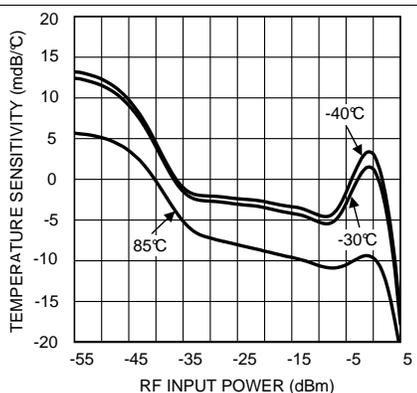
2500 MHz

Figure 46. Mean Temperature Sensitivity vs RF Input Power
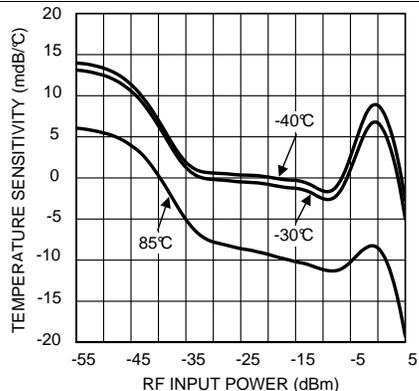
3000 MHz

Figure 47. Mean Temperature Sensitivity vs RF Input Power
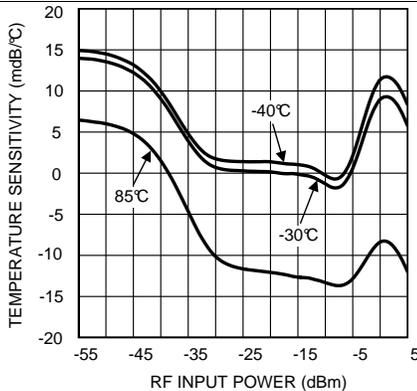
3500 MHz

Figure 48. Mean Temperature Sensitivity vs RF Input Power

Product Folder Links: *LMV221*

Typical Characteristics (continued)

Unless otherwise specified, V_{DD} = 2.7V, T_A = 25°C, measured on a limited number of samples.
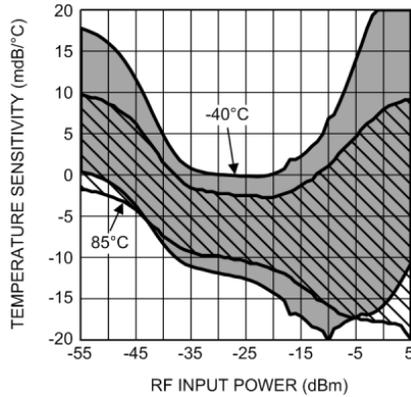
50 MHz

Figure 49. Temperature Sensitivity (Mean ±3 Sigma) vs RF Input Power
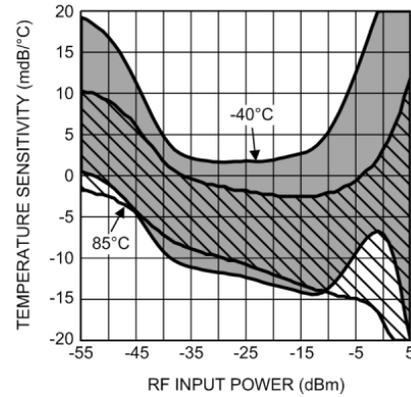
900 MHz

**Figure 50. Temperature Sensitivity (Mean ±3 Sigma) vs RF Input Power**
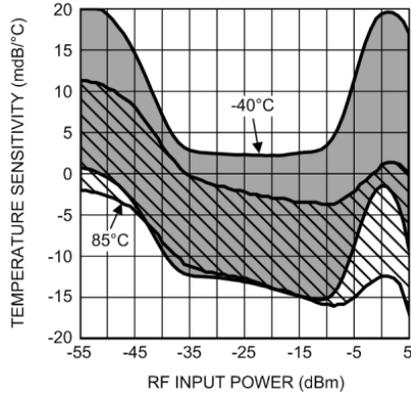
1855 MHz

Figure 51. Temperature Sensitivity (Mean ±3 Sigma) vs RF Input Power
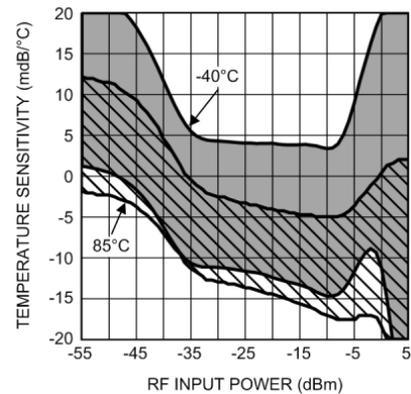
2500 MHz

Figure 52. Temperature Sensitivity (Mean ±3 Sigma) vs RF Input Power
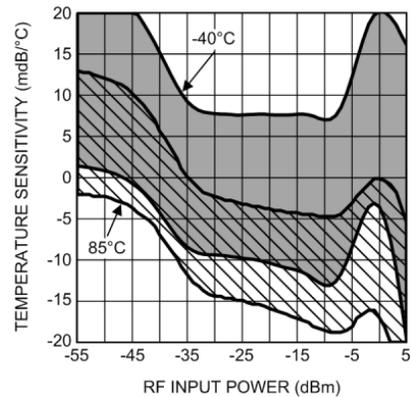
3000 MHz

Figure 53. Temperature Sensitivity (Mean ±3 Sigma) vs RF Input Power
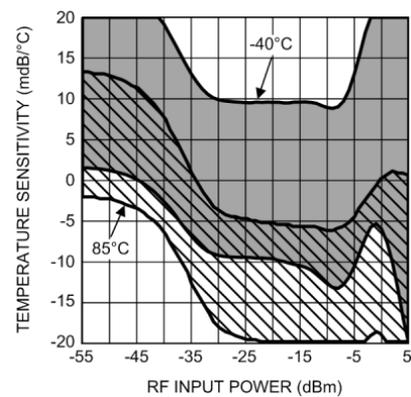
3500 MHz

Figure 54. Temperature Sensitivity (Mean ±3 Sigma) vs RF Input Power

Product Folder Links: *LMV221*

Typical Characteristics (continued)

Unless otherwise specified, V_{DD} = 2.7V, T_A = 25°C, measured on a limited number of samples.

900 MHz
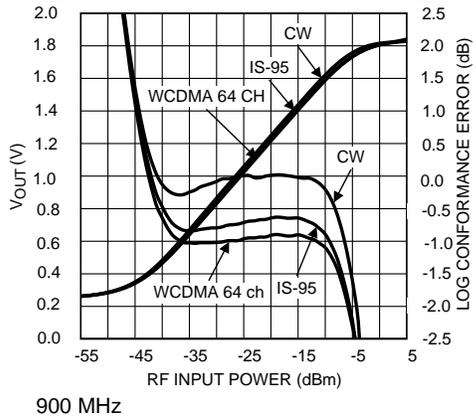
Figure 55. Output Voltage and Log Conformance Error vs RR Input Power for Various Modulation Types

1855 MHz
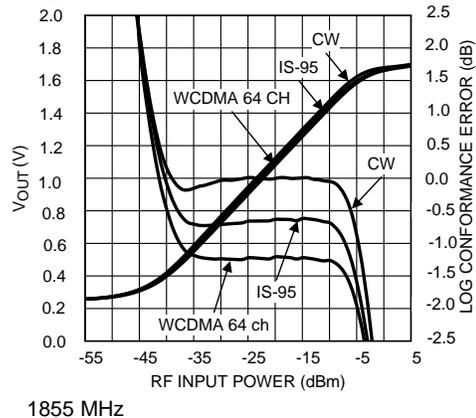
Figure 56. Output Voltage and Log Conformance Error vs RF Input Power for Various Modulation Types
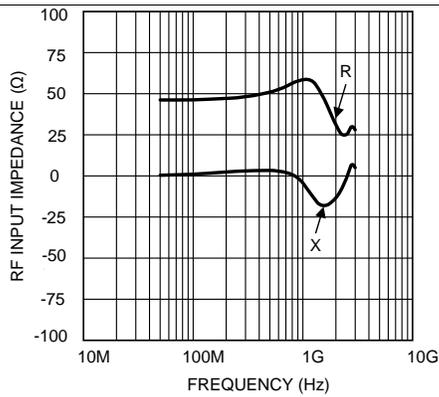
Figure 57. RF Input Impedance vs Frequency (Resistance and Reactance)
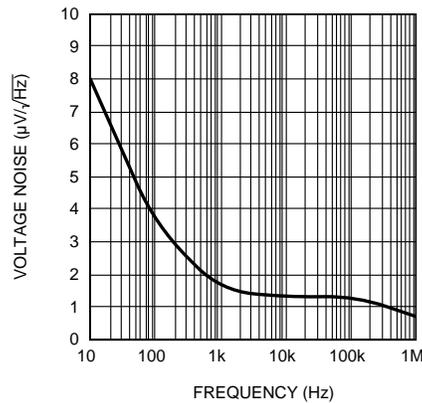
Figure 58. Output Noise Spectrum vs Frequency
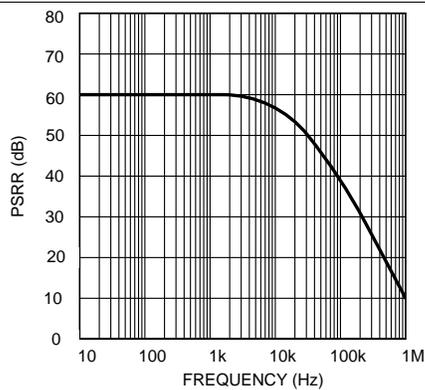
Figure 59. Power Supply Rejection Ratio vs Frequency
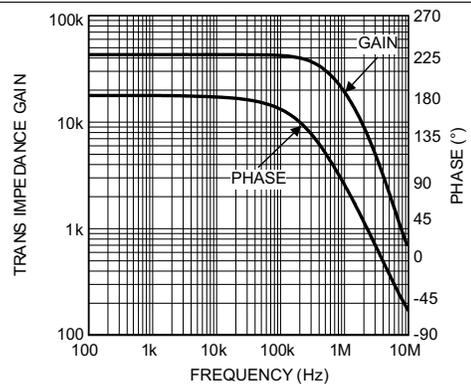
Figure 60. Output Amplifier Gain and Phase vs Frequency

Typical Characteristics (continued)

Unless otherwise specified, V_{DD} = 2.7V, T_A = 25°C, measured on a limited number of samples.
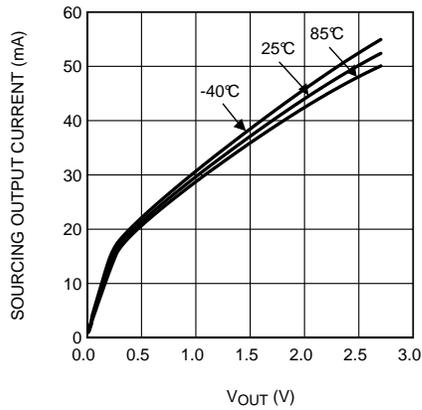
Figure 61. Sourcing Output Current vs Output Voltage
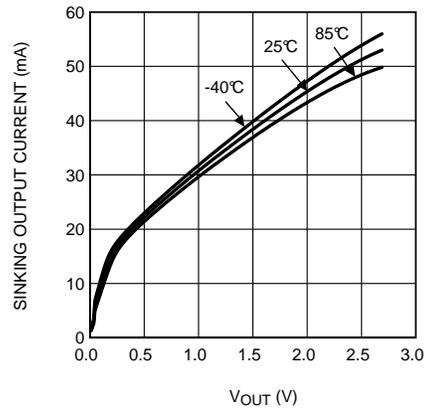
Figure 62. Sinking Output Current vs Output Voltage
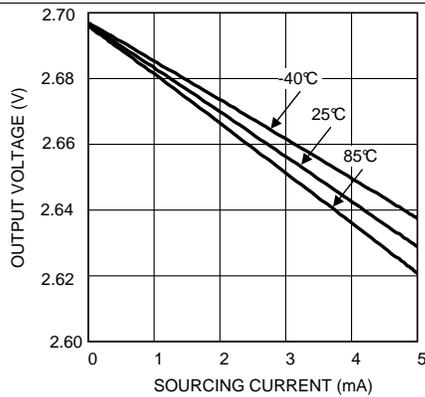
Figure 63. Output Voltage vs Sourcing Current
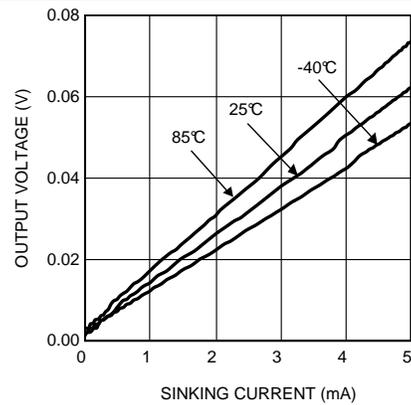
Figure 64. Output Voltage vs Sinking Current

Product Folder Links: *LMV221*

7 Detailed Description

7.1 Overview

The LMV221 is a versatile logarithmic RF power detector suitable for use in power measurement systems. The LMV221 is particularly well suited for CDMA and UMTS applications. It produces a DC voltage that is a measure for the applied RF power.

The core of the LMV221 is a progressive compression LOG detector consisting of four gain stages. Each of these saturating stages has a gain of approximately 10 dB and therefore achieves about 10 dB of the detector dynamic range. The five diode cells perform the actual detection and convert the RF signal to a DC current. This DC current is subsequently supplied to the transimpedance amplifier at the output, which converts it into an output voltage. In addition, the amplifier provides buffering of and applies filtering to the detector output signal. To prevent discharge of filtering capacitors between OUT and GND in shutdown, a switch is inserted at the amplifier input that opens in shutdown to realize a high impedance output of the device.

7.2 Functional Block Diagram
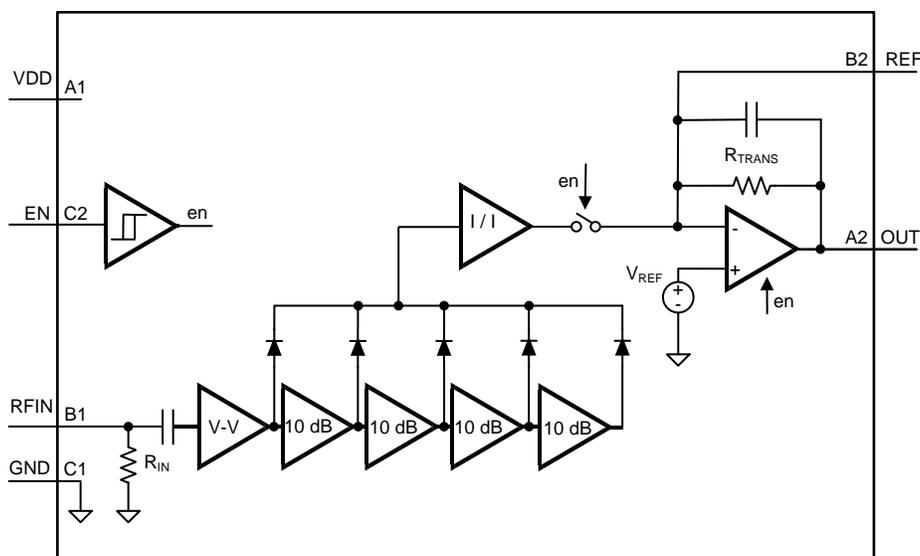
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7.3 Feature Description

7.3.1 Characteristics of the LMV221

The LMV221 is a logarithmic RF power detector with approximately 40-dB dynamic range. This dynamic range plus its logarithmic behavior make the LMV221 ideal for various applications such as wireless transmit power control for CDMA and UMTS applications. The frequency range of the LMV221 is from 50 MHz to 3.5 GHz, which makes it suitable for various applications.

The LMV221 transfer function is accurately temperature compensated. This makes the measurement accurate for a wide temperature range. Furthermore, the LMV221 can easily be connected to a directional coupler because of its 50-Ω input termination. The output range is adjustable to fit the ADC input range. The detector can be switched into a power saving shutdown mode for use in pulsed conditions.

7.3.2 Accurate Power Measurement

The power measurement accuracy achieved with a power detector is not only determined by the accuracy of the detector itself, but also by the way it is integrated into the application. In many applications some form of calibration is employed to improve the accuracy of the overall system beyond the intrinsic accuracy provided by the power detector. For example, for LOG-detectors calibration can be used to eliminate part to part spread of the LOG-slope and LOG-intercept from the overall power measurement system, thereby improving its power measurement accuracy.

Product Folder Links: *LMV221*

Feature Description (continued)

Calibration techniques can be used to improve the accuracy of a power measurement system beyond the intrinsic accuracy of the power detector itself. *LOG-Conformance Error* and *Temperature Drift Error* discuss power measurement systems using LOG-detectors, specifically the LMV221, but the more generic concepts can also be applied to other power detectors. Other factors influencing the power measurement accuracy, such as the resolution of the ADC reading the detector output signal, are not considered here because these factors are not fundamentally due to the power detector.

7.3.2.1 Concept of Power Measurements

Power measurement systems generally consists of two clearly distinguishable parts with different functions:

1. A power detector device, that generates a DC output signal (voltage) in response to the power level of the (RF) signal applied to its input.
2. An estimator that converts the measured detector output signal into a (digital) numeric value representing the power level of the signal at the detector input.

This conceptual configuration is shown in Figure 65.
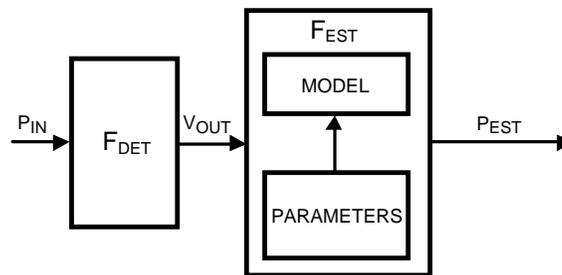
Figure 65. Generic Concept of a Power Measurement System

The core of the estimator is usually implemented as a software algorithm, receiving a digitized version of the detector output voltage. Its transfer F_{EST} from detector output voltage to a numerical output must be equal to the inverse of the detector transfer F_{DET} from (RF) input power to DC output voltage. If the power measurement system is ideal, that is, if no errors are introduced into the measurement result by the detector or the estimator, the measured power P_{EST} (the output of the estimator) and the actual input power P_{IN} must be identical. In that case, the measurement error E, the difference between the two, should be identically zero:

$$E = P_{EST} - P_{IN} \equiv 0$$

$$\Leftrightarrow P_{EST} = F_{EST}[F_{DET}(P_{IN})] = P_{IN}$$

$$\Leftrightarrow F_{EST}(V_{OUT}) = F_{DET}^{-1}(V_{OUT})$$

(1)

From Equation 1 it follows that one would design the F_{EST} transfer function to be the inverse of the F_{DET} transfer function.

In practice the power measurement error is not zero, due to the following effects:

- The detector transfer function is subject to various kinds of random errors that result in uncertainty in the detector output voltage; the detector transfer function is not exactly known.
- The detector transfer function might be too complicated to be implemented in a practical estimator.

The function of the estimator is then to *estimate* the input power P_{IN}, that is, to produce an output P_{EST} such that the power measurement error is, on average, minimized, based on the following information:

1. Measurement of the not-completely-accurate detector output voltage V_{OUT}
2. Knowledge about the detector transfer function F_{DET}, for example the shape of the transfer function, the types of errors present (part-to-part spread, temperature drift), and so forth.

Obviously the total measurement accuracy can be optimized by minimizing the uncertainty in the detector output signal (select an accurate power detector), and by incorporating as much accurate information about the detector transfer function into the estimator as possible.

Feature Description (continued)

The knowledge about the detector transfer function is condensed into a mathematical model for the detector transfer function, consisting of:

- A formula for the detector transfer function; and
- Values for the parameters in this formula.

The values for the parameters in the model can be obtained in various ways. They can be based on measurements of the detector transfer function in a precisely controlled environment (parameter extraction). If the parameter values are separately determined for each individual device, errors like part-to-part spread are eliminated from the measurement system.

Errors may occur when the operating conditions of the detector (for example, the temperature) become significantly different from the operating conditions during calibration (for example, room temperature). Examples of simple estimators for power measurements that result in a number of commonly used metrics for the power measurement error are discussed in *LOG-Conformance Error*, *Temperature Drift Error*, *Temperature Compensation* and *Temperature Drift Error*.

7.3.2.2 *LOG-Conformance Error*

Probably the simplest power measurement system that can be realized is obtained when the LOG-detector transfer function is modeled as a perfect linear-in-dB relationship between the input power and output voltage:

$$V_{OUT,MOD} = F_{DET,MOD}(P_{IN}) = K_{SLOPE}(P_{IN} - P_{INTERCEPT})$$

where

- K_{SLOPE} represents the LOG-slope and $P_{INTERCEPT}$ the LOG-intercept   (2)

The estimator based on Equation 2 implements the inverse of the model equation, that is:

$$P_{EST} = F_{EST}(V_{OUT}) = \frac{V_{OUT}}{K_{SLOPE}} + P_{INTERCEPT}$$

(3)

The resulting power measurement error, the LOG-conformance error, is thus equal to:

$$E_{LCE} = P_{EST} - P_{IN} = \frac{V_{OUT}}{K_{SLOPE}} - (P_{IN} - P_{INTERCEPT})$$

$$= \frac{V_{OUT} - V_{OUT,MOD}}{K_{SLOPE}}$$

(4)

The most important contributions to the LOG-conformance error are generally:

- The deviation of the actual detector transfer function from an ideal logarithm (the transfer function is nonlinear in dB).
- Drift of the detector transfer function over various environmental conditions, most importantly temperature; K_{SLOPE} and $P_{INTERCEPT}$ are usually determined for room temperature only.
- Part-to-part spread of the (room temperature) transfer function.

The latter component is conveniently removed by means of calibration, that is, if the LOG slope and LOG-intercept are determined for each individual detector device (at room temperature). This can be achieved by measurement of the detector output voltage (at room temperature) for a series of different power levels in the LOG-linear range of the detector transfer function. The slope and intercept can then be determined by means of linear regression.

An example of this type of error and its relationship to the detector transfer function is shown in Figure 66.

Feature Description (continued)
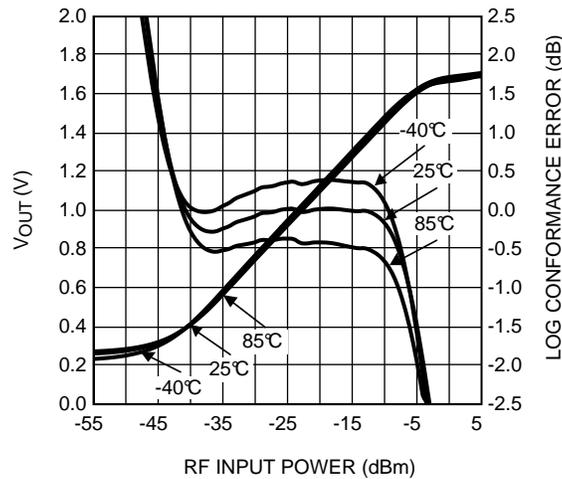
Figure 66. LOG-Conformance Error and LOG-Detector Transfer Function

In the center of the dynamic range of the detector, the LOG-conformance error is small, especially at room temperature; in this region the transfer function closely follows the linear-in-dB relationship while K_{SLOPE} and $P_{INTERCEPT}$ are determined based on room temperature measurements. At the temperature extremes the error in the center of the range is slightly larger due to the temperature drift of the detector transfer function. The error rapidly increases toward the top and bottom end of the detector's dynamic range; here the detector saturates and its transfer function starts to deviate significantly from the ideal LOG-linear model. The detector dynamic range is usually defined as the power range for which the LOG conformance error is smaller than a specified amount. Often an error of ±1 dB is used as a criterion.

7.3.2.3 Temperature Drift Error

A more accurate power measurement system can be obtained if the first error contribution, due to the deviation from the ideal LOG-linear model, is eliminated. This is achieved if the actual measured detector transfer function at room temperature is used as a model for the detector, instead of the ideal LOG-linear transfer function used in the previous section.

The formula used for such a detector is:

$$V_{OUT,MOD} = F_{DET}(P_{IN}, T_O)$$

where

- T_O represents the temperature during calibration (room temperature). (5)

The transfer function of the corresponding estimator is thus the inverse of this:

$$P_{EST} = F_{DET}^{-1}[V_{OUT(T)}, T_0]$$

where

- $V_{OUT}(T)$ represents the measured detector output voltage at the operating temperature T. (6)

The resulting measurement error is only due to drift of the detector transfer function over temperature and can be expressed as in Equation 7:

$$E_{DRIFT}(T, T_0) = P_{EST} - P_{IN} = F_{DET}^{-1}[V_{OUT(T)}, T_0] - P_{IN}$$

$$= F_{DET}^{-1}[V_{OUT}(T), T_0] - F_{DET}^{-1}[V_{OUT}(T), T)]$$

(7)

Feature Description (continued)

Unfortunately, the (numeric) inverse of the detector transfer function at different temperatures makes this expression rather impractical. However, because the drift error is usually small $V_{OUT}(T)$ is only slightly different from $V_{OUT}(T_O)$. This means that Equation 8 can be applied:

$$E_{DRIFT}(T,T_0) \approx E_{DRIFT}(T_0,T_0)$$
$$+ (T - T_0) \frac{\partial}{\partial T} \{F_{DET}^{-1}[V_{OUT}(T),T_0] - F_{DET}^{-1}[V_{OUT}(T),T]\} \tag{8}$$

This expression is easily simplified by taking the following considerations into account:
- The drift error at the calibration temperature $E(T_O,T_O)$ equals zero (by definition).
- The estimator transfer $F_{DET}(V_{OUT},T_O)$ is not a function of temperature; the estimator output changes over temperature only due to the temperature dependence of V_{OUT}.
- The actual detector input power P_{IN} is not temperature dependent (in the context of this expression).
- The derivative of the estimator transfer function to V_{OUT} equals approximately $1/K_{SLOPE}$ in the LOG-linear region of the detector transfer function (the region of interest).

Taking into account the preceding considerations, the simplified expression would be:

$$E_{DRIFT}(T,T_0) \approx (T - T_0) \frac{\partial}{\partial T} F_{DET}^{-1}[V_{OUT}(T),T_0]$$
$$= (T - T_0) \frac{\partial V_{OUT}(T)}{\partial T} \frac{\partial}{\partial V_{OUT}} F_{DET}^{-1}[V_{OUT}(T),T_0]$$
$$\approx \frac{V_{OUT}(T) - V_{OUT}(T_0)}{K_{SLOPE}} \tag{9}$$

Equation 9 is very similar to Equation 4 determined previously. The only difference is that instead of the output of the ideal LOG-linear model, the actual detector output voltage at the calibration temperature is now subtracted from the detector output voltage at the operating temperature.

Figure 67 depicts an example of the drift error.
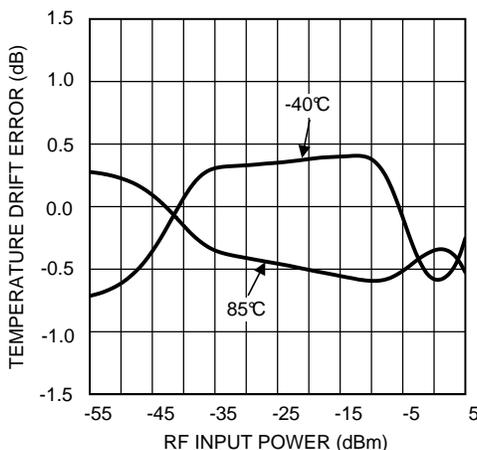
Figure 67. Temperature Drift Error of the LMV221 at f = 1855 MHz

In agreement with the definition, the temperature drift error is zero at the calibration temperature. Further, the main difference with the LOG-conformance error is observed at the top and bottom end of the detection range; instead of a rapid increase the drift error settles to a small value at high and low input power levels due to the fact that the detector saturation levels are relatively temperature independent.

Product Folder Links: *LMV221*

Feature Description (continued)

In a practical application it may not be possible to use the exact inverse detector transfer function as the algorithm for the estimator. For example, it may require too much memory or too much factory calibration time. However, using the ideal LOG-linear model in combination with a few extra data points at the top and bottom end of the detection range — where the deviation is largest — can already significantly reduce the power measurement error.

7.3.2.3.1 Temperature Compensation

A further reduction of the power measurement error is possible if the operating temperature is measured in the application. For this purpose, the detector model used by the estimator should be extended to cover the temperature dependency of the detector.

Because the detector transfer function is generally a smooth function of temperature (the output voltage changes gradually over temperature), the temperature is in most cases adequately modeled by a first-order or second-order polynomial (see Equation 10).

$$V_{OUT,MOD} = F_{DET}(P_{IN}, T_0)[1 + (T-T_0)TC_1(P_{IN})$$
$$+ (T-T_0)^2 TC_2(P_{IN}) + O(T^3)]$$

(10)

The required temperature dependence of the estimator, to compensate for the detector temperature dependence can be approximated similarly:

$$P_{EST} = F_{DET}^{-1}[V_{OUT}(T), T_0]\{1 + (T-T_0)S_1[V_{OUT}(T)] +$$
$$+ (T-T_0)^2 S_2[V_{OUT}(T)] + O(T^3)\}$$
$$\approx F_{DET}^{-1}[V_{OUT}(T), T_0]\{1 + (T-T_0)S_1[V_{OUT}(T)]\}$$

(11)

The last approximation results from the fact that a first-order temperature compensation is usually sufficiently accurate. For second and higher-order compensation a similar approach can be followed.

Ideally, the temperature drift could be completely eliminated if the measurement system is calibrated at various temperatures and input power levels to determine the temperature sensitivity S_1. In a practical application, however, that is usually not possible due to the associated high costs. The alternative is to use the average temperature drift in the estimator, instead of the temperature sensitivity of each device individually. In this way it is possible to eliminate the systematic (reproducible) component of the temperature drift without the need for calibration at different temperatures during manufacturing. What remains is the random temperature drift, which differs from device to device. (see Figure 68). The graph at the left of Figure 68 schematically represents the behavior of the drift error versus temperature at a certain input power level for a large number of devices.
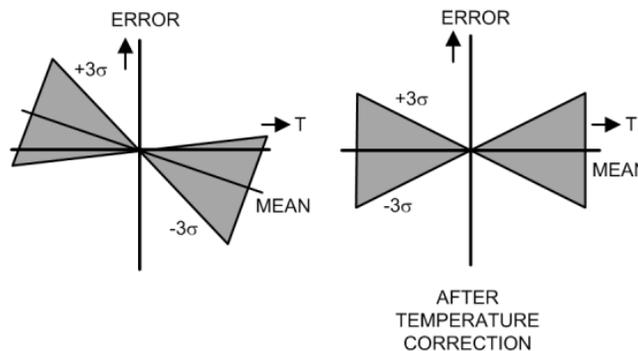
Figure 68. Elimination of the Systematic Component from the Temperature Drift

Feature Description (continued)

The mean drift error represents the reproducible (systematic) part of the error, while the mean ±3 sigma limits represent the combined systematic plus random error component. Obviously the drift error must be zero at calibration temperature T_0. If the systematic component of the drift error is included in the estimator, the total drift error becomes equal to only the random component, as shown in the graph at the right of Figure 68. A significant reduction of the temperature drift error can be achieved in this way only if:

*   The systematic component is significantly larger than the random error component (otherwise the difference is negligible).
*   The operating temperature is measured with sufficient accuracy.

It is essential for the effectiveness of the temperature compensation to assign the appropriate value to the temperature sensitivity S_1. Two different methods can be followed to determine this parameter:

 1. Determination of a single value to be used over the entire operating temperature range.
 2. Division of the operating temperature range in segments and use of separate values for each of the segments.

For the first method, the accuracy of the extracted temperature sensitivity increases when the number of measurement temperatures increases. Linear regression to temperature can then be used to determine the two parameters of the linear model for the temperature drift error: the first order temperature sensitivity S_1 and the best-fit (room temperature) value for the power estimate at T_0: $F_{DET}[V_{OUT}(T),T_0]$. Note that to achieve an overall (over all temperatures) minimum error, the room temperature drift error in the model can be non-zero at the calibration temperature (which is not in agreement with the strict definition).

The second method does not have this drawback but is more complex. In fact, segmentation of the temperature range is a form of higher-order temperature compensation using only a first-order model for the different segments: one for temperatures below 25°C, and one for temperatures above 25°C. The mean (or typical) temperature sensitivity is the value to be used for compensation of the systematic drift error component. Figure 69 and Figure 70 show the temperature drift error without and with temperature compensation using two segments. With compensation the systematic component is completely eliminated; the remaining random error component is centered around zero. Note that the random component is slightly larger at −40°C than at +85°C.

Figure 69. Temperature Drift Error without Temperature Compensation

Figure 70. Temperature Drift Error With Temperature Compensation
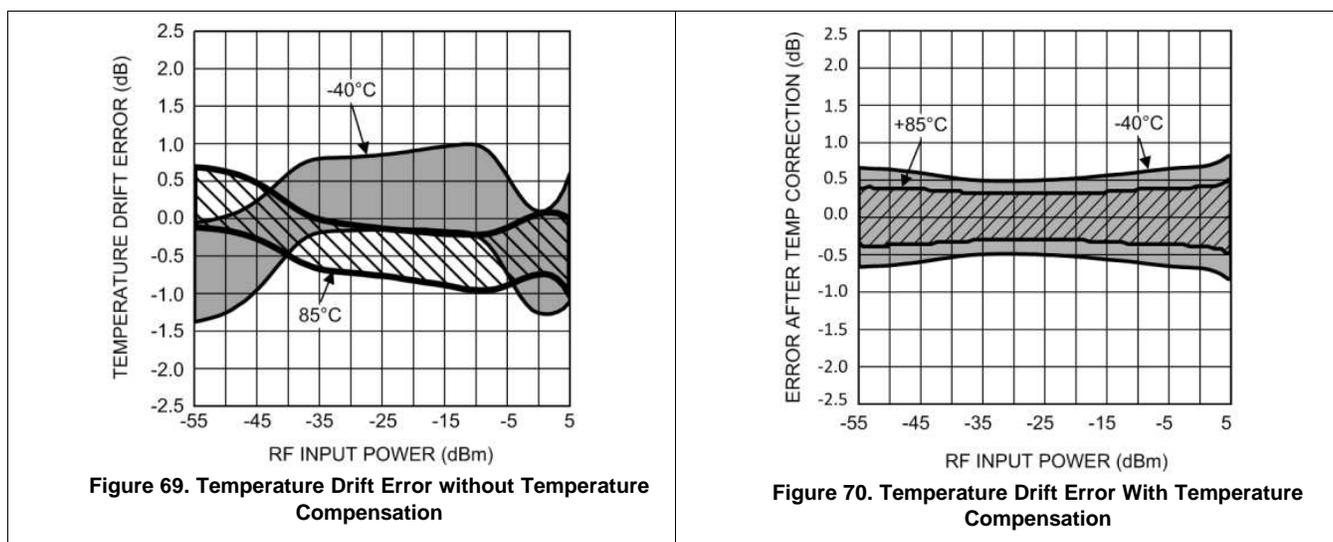
In a practical power measurement system, temperature compensation is usually only applied to a small power range around the maximum power level for two reasons:

 1. The various communication standards require the highest accuracy in this range to limit interference.
 2. The temperature sensitivity itself is a function of the power level it becomes impractical to store a large number of different temperature sensitivity values for different power levels.

The *2.7-V DC and AC Electrical Characteristics* specifies the temperature sensitivity for the aforementioned two segments at an input power level of −10 dBm (near the top-end of the detector dynamic range). The typical value represents the mean which is to be used for calibration.

Feature Description (continued)

7.3.2.3.2 Differential Power Errors

Many third-generation communication systems contain a power control loop through the base station and mobile unit that require frequent updates to the transmit-power level by a small amount (typically 1 dB). For such applications it is important that the actual change of the transmit power is sufficiently close to the requested power change.

The error metrics in this data sheet that describe the accuracy of the detector for a change in the input power are $E_{1\ dB}$ (for a 1-dB change in the input power) and $E_{10\ dB}$ (for a 10-dB step, or ten consecutive steps of 1 dB). Because it can be assumed that the temperature does not change during the power step the differential error equals the difference of the drift error at the two involved power levels:

$$E_{1dB(P_{IN},T)} = E_{DRIFT}(P_{IN}+1dB,T) - E_{DRIFT}(P_{IN},T)$$

$$E_{10dB(P_{IN},T)} = E_{DRIFT}(P_{IN}+10dB,T) - E_{DRIFT}(P_{IN},T)$$

(12)

NOTE

The step error increases significantly when one (or both) power levels in the above expression are outside the detector dynamic range. For $E_{10\ dB}$ this occurs when P_{IN} is less than 10 dB below the maximum input power of the dynamic range, P_{MAX}.

7.4 Device Functional Modes

7.4.1 Shutdown

To save power, the LMV221 can be brought into a low power-shutdown mode. The device is active for EN = high (V_{EN} > 1.1 V) and in the low power-shutdown mode for EN = low (V_{EN} < 0.6 V). In this state the output of the LMV221 is switched to a high impedance mode. Using the shutdown function, care must be taken not to exceed the absolute maximum ratings. Forcing a voltage to the enable input that is 400 mV higher than V_{DD} or 400 mV lower than GND damages the device, and further operation is not ensured. The absolute maximum ratings can also be exceeded when the enable EN is switched to high (from shutdown to active mode) while the supply voltage is low (off). This must be prevented at all times. A possible solution to protect the device is to add a resistor of 100 kΩ in series with the enable input.

7.4.1.1 Output Behavior in Shutdown

In order to save power, the LMV221 can be used in pulsed mode so that it is active to perform the power measurement only during a fraction of the time. During the remaining time the device is in low-power shutdown. Applications using this approach usually require that the output value is available at all times, including when the LMV221 is in shutdown. The settling time in active mode, however, must not become excessively large. This can be achieved by the combination of the LMV221 and a low pass output filter (see Figure 75).

In active mode, the filter capacitor C_S is charged to the output voltage of the LMV221, which in this mode has a low output impedance to enable fast settling. During shutdown mode, the capacitor should preserve this voltage. Discharge of C_S through any current path must therefore be avoided in shutdown. The output impedance of the LMV221 becomes high in shutdown, thus, the discharge current cannot flow from the capacitor top plate, through R_S and the device OUT pin to GND. This is detected by the internal shutdown mechanism of the output amplifier and by the switch depicted in Figure 79. Additionally, the ADC input impedance must be high to prevent a possible discharge path through the ADC.

Product Folder Links: *LMV221*

8   Application and Implementation

> **NOTE**
>
> Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

8.1   Application Information

8.1.1   Functionality and Applications of RF Power Detectors

8.1.1.1   *Functionality of RF Power Detectors*

An RF power detector is a device that produces a DC output voltage in response to the RF power level of the signal applied to its input. A wide variety of power detectors can be distinguished, each having certain properties that suit a particular application. This section provides an overview of the key characteristics of power detectors, and discusses the most important types of power detectors. The functional behavior of the LMV221 is discussed in detail.

8.1.1.1.1   Key Characteristics of RF Power Detectors

Power detectors are used to accurately measure the power of a signal inside the application. The attainable accuracy of the measurement is therefore dependent upon the accuracy and predictability of the detector transfer function from the RF input power to the DC output voltage.

Certain key characteristics determine the accuracy of RF detectors and they are classified accordingly:
- Temperature Stability
- Dynamic Range
- Waveform Dependency
- Transfer Shape

Generally, the transfer function of RF power detectors is slightly temperature dependent. This temperature drift reduces the accuracy of the power measurement, because most applications are calibrated at room temperature. In such systems, the temperature drift significantly contributes to the overall system power measurement error. The temperature stability of the transfer function differs for the various types of power detectors. Generally, power detectors that contain only one or few semiconductor devices (diodes, transistors) operating at RF frequencies attain the best temperature stability.

The dynamic range of a power detector is the input power range for which it creates an accurately reproducible output signal. What is considered accurate is determined by the applied criterion for the detector accuracy; the detector dynamic range is thus always associated with certain power measurement accuracy. This accuracy is usually expressed as the deviation of its transfer function from a certain predefined relationship, such as *linear in dB* for LOG detectors and *square-law* transfer (from input RF voltage to DC output voltage) for mean-square detectors. For LOG-detectors, the dynamic range is often specified as the power range for which its transfer function follows the ideal linear-in-dB relationship with an error smaller than or equal to ±1 dB. Again, the attainable dynamic range differs considerably for the various types of power detectors.

According to its definition, the average power is a metric for the average energy content of a signal and is not directly a function of the shape of the signal in time. In other words, the power contained in a 0-dBm sine wave is identical to the power contained in a 0-dBm square wave or a 0-dBm WCDMA signal; all these signals have the same average power. Depending on the internal detection mechanism, though, power detectors may produce a slightly different output signal in response to the aforementioned waveforms, even though their average power level is the same. This is due to the fact that not all power detectors strictly implement the definition formula for signal power, being the mean of the square of the signal. Most types of detectors perform some mixture of peak detection and average power detection. A waveform independent detector response is often desired in applications that exhibit a large variety of waveforms, such that separate calibration for each waveform becomes impractical.

Application Information (continued)

The shape of the detector transfer function from the RF input power to the DC output voltage determines the required resolution of the ADC connected to it. The overall power measurement error is the combination of the error introduced by the detector, and the quantization error contributed by the ADC. The impact of the quantization error on the overall transfer's accuracy is highly dependent on the detector transfer shape, as shown in Figure 71 and Figure 72.

Figure 71. Convex Detector Transfer Function

Figure 72. Linear Transfer Function
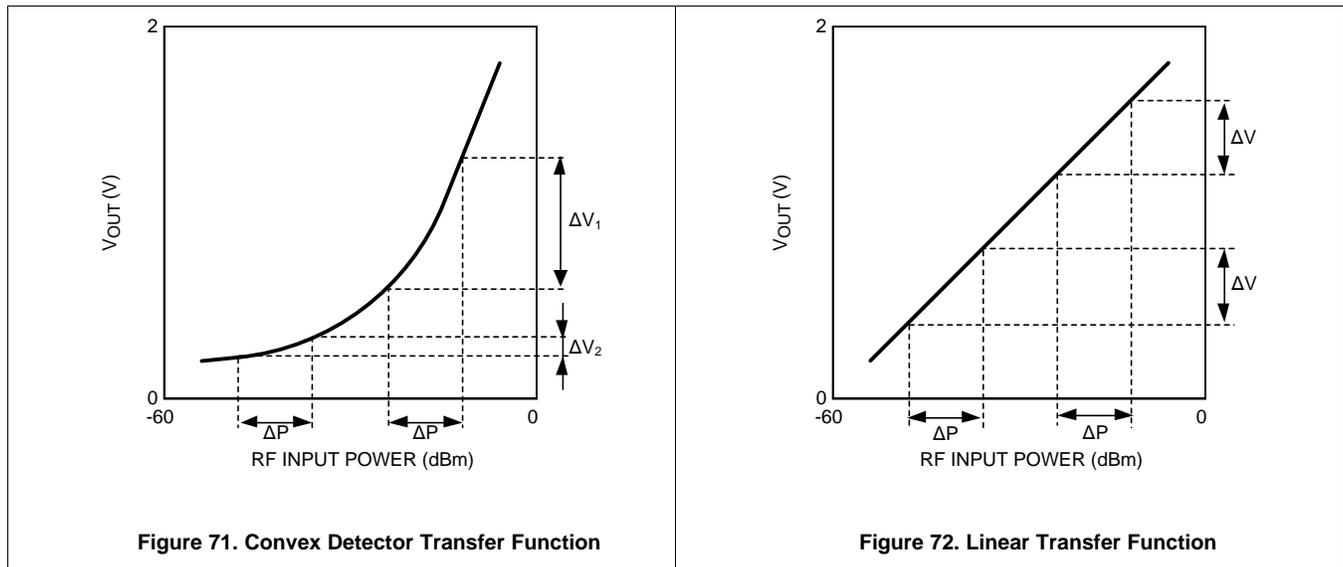
Figure 71 and Figure 72 shows two different representations of the detector transfer function. In both Figure 71 and Figure 72 the input power along the horizontal axis is displayed in dBm because most applications specify power accuracy requirements in dBm (or dB). Figure 71 shows a convex detector transfer function, while the transfer function on the right hand side is linear (in dB). The slope of the detector transfer function — the detector conversion gain – is of key importance for the impact of the quantization error on the total measurement error. If the detector transfer function slope is low, a change, ΔP, in the input power results only in a small change of the detector output voltage, such that the quantization error is relatively large. On the other hand, if the detector transfer function slope is high, the output voltage change for the same input power change will be large, such that the quantization error is small. Figure 72 has a very low slope at low input power levels, resulting in a relatively large quantization error. Therefore, to achieve accurate power measurement in this region, a high-resolution ADC is required. On the other hand, for high input power levels the quantization error are very small due to the steep slope of the curve in this region. For accurate power measurement in this region, a much lower ADC resolution is sufficient. Figure 71 has a constant slope over the power range of interest, such that the required ADC resolution for a certain measurement accuracy is constant. For this reason, the LOG-linear curve in Figure 71 generally leads to the lowest ADC resolution requirements for certain power measurement accuracy.

Product Folder Links: *LMV221*

Application Information (continued)

8.1.1.1.2 Types of RF Power Detectors

Three different detector types are distinguished based on the four characteristics previously discussed:
* *Diode Detector*
* *(Root) Mean Square (R)MS) Detector*
* *Logarithmic Detectors*

8.1.1.1.2.1 Diode Detector

A diode is one of the simplest types of RF detectors. As depicted in Figure 73, the diode converts the RF input voltage into a rectified current. This unidirectional current charges the capacitor. The RC time constant of the resistor and the capacitor determines the amount of filtering applied to the rectified (detected) signal.
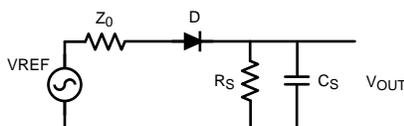
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Figure 73. Diode Detector

The advantages and disadvantages can be summarized as follows:
* The *temperature stability* of the diode detectors is generally very good because they contain only one semiconductor device that operates at RF frequencies.
* The *dynamic range* of diode detectors is poor. The conversion gain from the RF input power to the output voltage quickly drops to very low levels when the input power decreases. Typically a dynamic range of 20 dB to 25 dB can be achieved with this type of detector.
* The response of diode detectors is *waveform dependent*. As a consequence of this dependency, for example, its output voltage for a 0-dBm WCDMA signal is different than for a 0-dBm unmodulated carrier. This is due to the fact that the diode measures peak power instead of average power. The relation between peak power and average power is dependent on the wave shape.
* The *transfer shape* of diode detectors puts high requirements on the resolution of the ADC that reads their output voltage. Especially at low input power levels a very high ADC resolution is required to achieve sufficient power measurement accuracy (See Figure 71).

8.1.1.1.2.2 (Root) Mean Square (R)MS) Detector

This type of detector is particularly suited for the power measurements of RF modulated signals that exhibits large peak-to-average power ratio variations. This is because its operation is based on direct determination of the average power and not – like the diode detector – of the peak power.

The advantages and disadvantages can be summarized as follows:
* The *temperature stability* of (R)MS detectors is almost as good as the temperature stability of the diode detector; only a small part of the circuit operates at RF frequencies, while the rest of the circuit operates at low frequencies.
* The *dynamic range* of (R)MS detectors is limited. The lower end of the dynamic range is limited by internal device offsets.
* The response of (R)MS detectors is highly *waveform independent*. This is a key advantage compared to other types of detectors in applications that employ signals with high peak-to-average power variations. For example, the (R)MS detector response to a 0-dBm WCDMA signal and a 0-dBm unmodulated carrier is essentially equal.
* The *transfer shape* of R(MS) detectors has many similarities with the diode detector and is therefore subject to similar disadvantages with respect to the ADC resolution requirements (see Figure 72).

Application Information (continued)

8.1.1.1.2.3 Logarithmic Detectors

The transfer function of a logarithmic detector has a linear in dB response, which means that the output voltage changes linearly with the RF power in dBm. This is convenient because most communication standards specify transmit power levels in dBm as well.

The advantages and disadvantages can be summarized as follows:

- The *temperature stability* of the LOG detector transfer function is generally not as good as the stability of diode and R(MS) detectors. This is because a significant part of the circuit operates at RF frequencies.
- The *dynamic range* of LOG detectors is usually much larger than that of other types of detectors.
- Because LOG detectors perform a kind of peak detection their response is *wave form dependent*, similar to diode detectors.
- The *transfer shape* of LOG detectors puts the lowest possible requirements on the ADC resolution (See Figure 72).
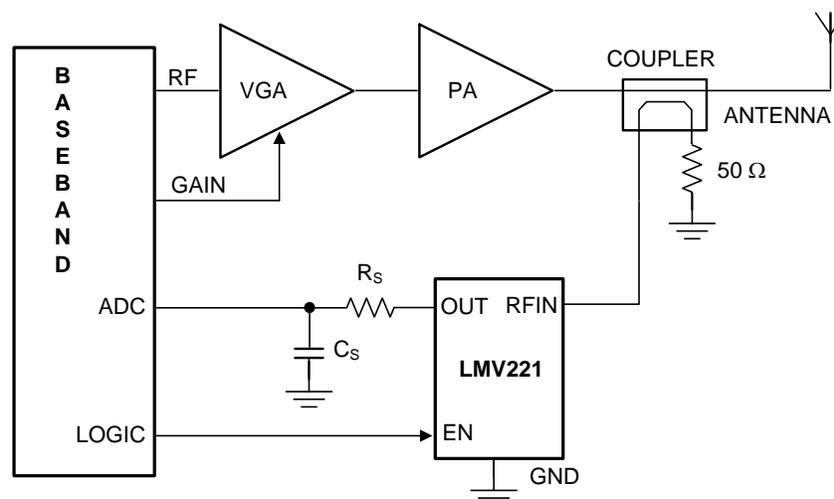
8.2 Typical Applications

RF power detectors can be used in a wide variety of applications. Figure 74 shows the LMV221 in a transmit power-control system, and Figure 82 measures the voltage standing wave ratio (VSWR).

8.2.1 Application With Transmit Power Control Loop

The key benefit of a transmit power control loop circuit is that it makes the transmit power insensitive to changes in the power amplifier (PA) gain control function, such as changes due to temperature drift. When a control loop is used, the transfer function of the PA is eliminated from the overall transfer function. Instead, the overall transfer function is determined by the power detector. The overall transfer function accuracy depends thus on the RF detector accuracy. The LMV221 is especially suited for this application, due to the accurate temperature stability of its transfer function.

Figure 74 shows a block diagram of a typical transmit power control system. The output power of the PA is measured by the LMV221 through a directional coupler. The measured output voltage of the LMV221 is filtered and subsequently digitized by the ADC inside the baseband chip. The baseband adjusts the PA output power level by changing the gain control signal of the RF VGA accordingly. With an input impedance of 50 Ω, the LMV221 can be directly connected to a 30-dB directional coupler without the need for an additional external attenuator. The setup can be adjusted to various PA output ranges by selection of a directional coupler with the appropriate coupling factor.

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Figure 74. Transmit Power Control System

Typical Applications (continued)

8.2.1.1 Design Requirements

Some of the design requirements for this logarithmic RMS power detector include:

Table 1. Design Parameters

DESIGN PARAMETER	EXAMPLE VALUE
Supply voltage	2.7 V
RF input frequency (unmodulated continuous wave)	1855 MHz
Minimum input power for E_{LC} = 1 dB	–42.9 dBm
Maximum input power for E_{LC} = 1 dB	–5.5 dBm
Maximum output voltage, P_{IN} = –5 dBm	1.61 V

8.2.1.2 Detailed Design Procedure

8.2.1.2.1 Detector Interfacing

For optimal performance of the LMV221 device, it is important that all its pins are connected to the surrounding circuitry in the appropriate way. Starting from the *Functional Block Diagram* the function of each pin is elaborated in the following sections. The details of the electrical interfacing are separately discussed for each pin. Output filtering options and the differences between single ended and differential interfacing with an ADC are also discussed in detail in the following subsections.

8.2.1.2.1.1 RF Input

RF parts typically use a characteristic impedance of 50 Ω. To comply with this standard the LMV221 has an input impedance of 50 Ω. Using a characteristic impedance other then 50 Ω causes a shift of the logarithmic intercept with respect to the value given in the *2.7-V DC and AC Electrical Characteristics*. This intercept shift can be calculated according to Equation 13.

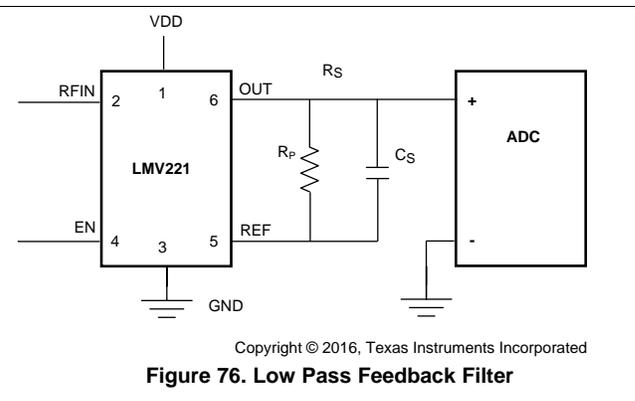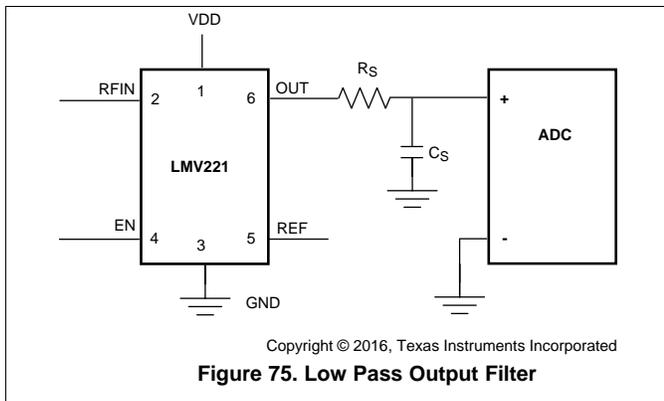$$P_{INT\text{-}SHIFT} = 10 \: LOG \left(\frac{2 \: R_{SOURCE}}{R_{SOURCE} + 50} \right)$$

(13)

The intercept shifts to higher power levels for R_{SOURCE} > 50 Ω, and shifts to lower power levels for R_{SOURCE} < 50 Ω.

8.2.1.2.1.2 Output and Reference

The possible filtering techniques that can be applied to reduce ripple in the detector output voltage are discussed in *Filtering*. In addition, two different topologies to connect the LMV221 to an ADC are elaborated.

8.2.1.2.1.2.1 Filtering

The output voltage of the LMV221 is a measure for the applied RF signal on the RF input pin. Usually, the applied RF signal contains AM modulation that causes low frequency ripple in the detector output voltage. CDMA signals, for instance, contain a large amount of amplitude variations. Filtering of the output signal can be used to eliminate this ripple. The filtering can either be achieved by a low pass output filter or a low pass feedback filter. Those two techniques are shown in Figure 75 and Figure 76.

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Figure 75. Low Pass Output Filter

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Figure 76. Low Pass Feedback Filter

Depending on the system requirements one of the these filtering techniques can be selected. The low pass output filter has the advantage that it preserves the output voltage when the LMV221 is brought into shutdown. This is elaborated in *Output Behavior in Shutdown*. In the feedback filter, resistor R_P discharges capacitor C_P in shutdown and therefore changes the output voltage of the device.

A disadvantage of the low pass output filter is that the series resistor R_S limits the output drive capability. This may cause inaccuracies in the voltage read by an ADC when the ADC input impedance is not significantly larger than R_S. In that case, the current flowing through the ADC input induces an error voltage across filter resistor R_S. The low pass feedback filter does not have this disadvantage.
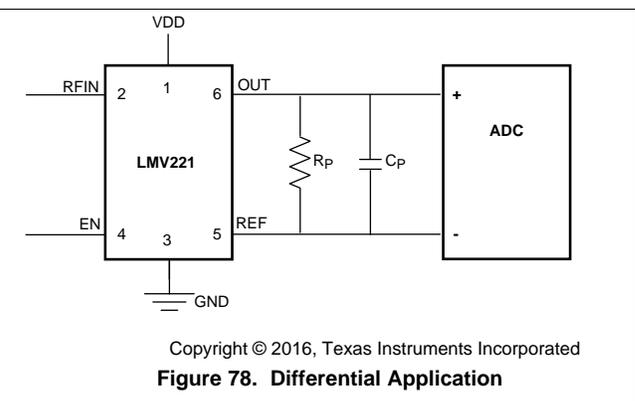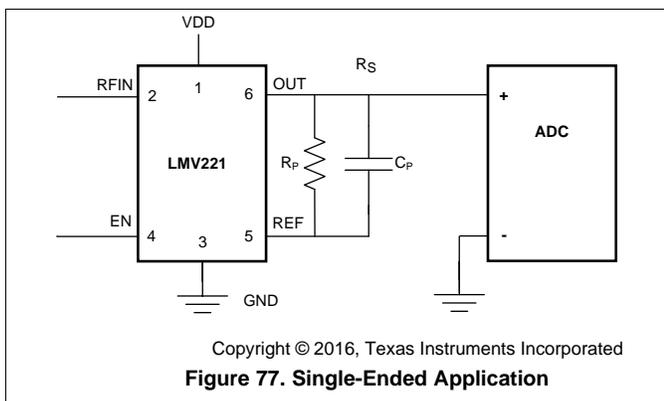
NOTE

Note that adding an external resistor between OUT and REF reduces the transfer gain (LOG-slope and LOG-intercept) of the device. The internal feedback resistor sets the gain of the transimpedance amplifier.

The filtering of the low pass output filter is achieved by resistor R_S and capacitor C_S. The −3 dB bandwidth of this filter can then be calculated by: $f_{-3\ dB} = 1 / 2\pi R_S C_S$. The bandwidth of the low pass feedback filter is determined by external resistor R_P in parallel with the internal resistor R_{TRANS}, and external capacitor C_P in parallel with internal capacitor C_{TRANS} (see Figure 79). The −3 dB bandwidth of the feedback filter can be calculated by $f_{-3\ dB} = 1 / 2\pi (R_P // R_{TRANS})(C_P + C_{TRANS})$. The bandwidth set by the internal resistor and capacitor (when no external components are connected between OUT and REF) equals $f_{-3\ dB} = 1 / 2\pi R_{TRANS} C_{TRANS} = 450$ kHz.

8.2.1.2.1.3 Interface to the ADC

The LMV221 can be connected to the ADC with a single-ended or a differential topology. The single ended topology connects the output of the LMV221 to the input of the ADC and the reference pin is not connected. In a differential topology, both the output and the reference pins of the LMV221 are connected to the ADC. The topologies are depicted in Figure 77 and Figure 78.

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Figure 77. Single-Ended Application

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Figure 78. Differential Application

The differential topology has the advantage that it is compensated for temperature drift of the internal reference voltage. This can be explained by looking at the transimpedance amplifier of the LMV221 (Figure 79).
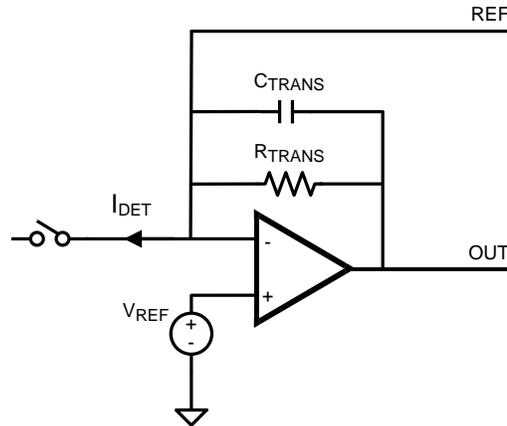
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Figure 79. Output Stage of the LMV221

Equation 14 shows that the output of the amplifier is set by the detection current I_{DET} multiplied by the resistor R_{TRANS} plus the reference voltage V_{REF}:

$$V_{OUT} = I_{DET} R_{TRANS} + V_{REF}$$

where

- I_{DET} represents the detector current that is proportional to the RF input power. (14)

Equation 14 shows that temperature variations in V_{REF} are also present in the output V_{OUT}. In case of a single ended topology the output is the only pin that is connected to the ADC. The ADC voltage for single ended is thus:

$$V_{ADC} = I_{DET} R_{TRANS} + V_{REF}$$ (15)

A differential topology also connects the reference pin, which is the value of reference voltage V_{REF}. The ADC reads $V_{OUT} - V_{REF}$:

$$V_{ADC} = V_{OUT} - V_{REF} = I_{DET} R_{TRANS}$$ (16)

Equation 16 no longer contains the reference voltage V_{REF} anymore. Temperature variations in this reference voltage are therefore not measured by the ADC.
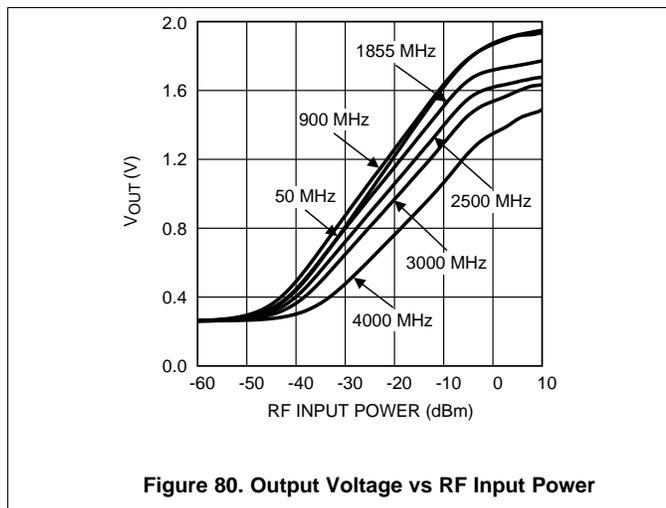
8.2.1.3 Application Curves
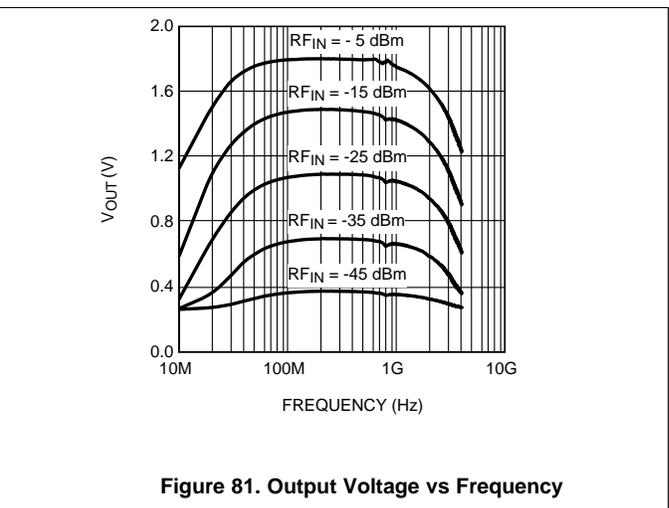

Figure 80. Output Voltage vs RF Input Power

Figure 81. Output Voltage vs Frequency

Product Folder Links: *LMV221*

8.2.2 Application With Voltage Standing Wave Ratio (VSWR) Measurement

Transmission in RF systems requires matched termination by the proper characteristic impedance at the transmitter and receiver side of the link. In wireless transmission systems, however, matched termination of the antenna can rarely be achieved. The part of the transmitted power that is reflected at the antenna bounces back toward the PA and may cause standing waves in the transmission line between the PA and the antenna. These standing waves can attain unacceptable levels that may damage the PA. A VSWR measurement is used to detect such an occasion. It acts as an alarm function to prevent damage to the transmitter.

VSWR is defined as the ratio of the maximum voltage divided by the minimum voltage at a certain point on the transmission line:

$$\text{VSWR} = \frac{1 + |\Gamma|}{1 - |\Gamma|}$$

where

- $\Gamma = V_{\text{REFLECTED}} / V_{\text{FORWARD}}$ denotes the reflection coefficient. (17)

This means that to determine the VSWR, both the forward (transmitted) and the reflected power levels must be measured. This can be accomplished by using two LMV221 RF power detectors according to Figure 82. A directional coupler is used to separate the forward and reflected power waves on the transmission line between the PA and the antenna. One secondary output of the coupler provides a signal proportional to the forward power wave, the other secondary output provides a signal proportional to the reflected power wave. The outputs of both RF detectors that measure these signals are connected to a microcontroller or baseband that calculates the VSWR from the detector output signals.
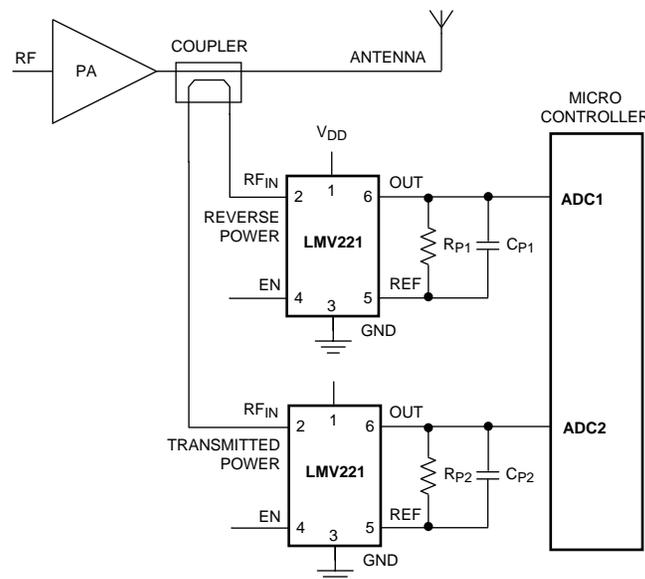
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Figure 82. VSWR Application

9 Power Supply Recommendations

The LMV221 is designed to operate from an input voltage supply range from 2.7 V to 3.3 V. This input voltage must be well regulated. Enable voltage levels lower than 400 mV below GND could lead to incorrect operation of the device. Also, the resistance of the input supply rail must be low enough to ensure correct operation of the device.

Product Folder Links: *LMV221*

10 Layout

10.1 Layout Guidelines

As with any other RF device, careful attention must be paid to the board layout. If the board layout is not properly designed, unwanted signals can easily be detected or interference picked up.

Electrical signals (voltages and currents) need a finite time to travel through a trace or transmission line. RF voltage levels at the generator side and at the detector side can therefore be different. This is not only true for the RF strip line, but for all traces on the PCB. Signals at different locations or traces on the PCB are in a different phase of the RF frequency cycle. Phase differences in, for example, the voltage across neighboring lines, may result in crosstalk between lines due to parasitic capacitive, or inductive coupling. This crosstalk is further enhanced by the fact that all traces on the PCB are susceptible to resonance. The resonance frequency depends on the trace geometry. Traces are particularly sensitive to interference when the length of the trace corresponds to a quarter of the wavelength of the interfering signal or a multiple thereof.

10.1.1 Supply Lines

Because the PSRR of the LMV221 is finite, variations of the supply can result in some variation at the output. This can be caused among others by RF injection from other parts of the circuitry or the on/off switching of the PA.

10.1.1.1 Positive Supply (VDD)

In order to minimize the injection of RF interference into the LMV221 through the supply lines, the phase difference between the PCB traces connecting to VDD and GND must be minimized. A suitable way to achieve this is to short both connections for RF. This can be done by placing a small decoupling capacitor between the VDD and GND. It must be placed as close to the device VDD and GND pins as possible as shown in Figure 85. Be aware that the resonance frequency of the capacitor itself must be above the highest RF frequency used in the application, because the capacitor acts as an inductor above its resonance frequency.

Low frequency-supply voltage variations due to PA switching might result in a ripple at the output voltage. The LMV221 has a PSRR of 60 dB for low frequencies.

10.1.1.2 Ground (GND)

The LMV221 must have a ground plane free of noise and other disturbing signals. It is important to separate the RF ground return path from the other grounds. This is due to the fact that the RF input handles large voltage swings. A power level of 0 dBm causes a voltage swing larger than 0.6 V_{PP} over the internal 50-Ω input resistor, resulting in a significant RF return current toward the source. Therefore, TI recommends that the RF ground return path not be used for other circuits in the design. The RF path must be routed directly back to the source without loops.

10.1.2 RF Input Interface

The LMV221 is designed to be used in RF applications having a characteristic impedance of 50 Ω. To achieve this impedance, the input of the LMV221 must be connected via a 50-Ω transmission line. Transmission lines can be easily created on PCBs using microstrip or (grounded) coplanar waveguide (GCPW) configurations. For more details about designing microstrip or GCPW transmission lines, TI recommends a microwave designer handbook is recommended.

10.1.3 Microstrip Configuration

One way to create a transmission line is to use a microstrip configuration. A cross section of the configuration is shown in Figure 83, assuming a two-layer PCB.

Product Folder Links: LMV221
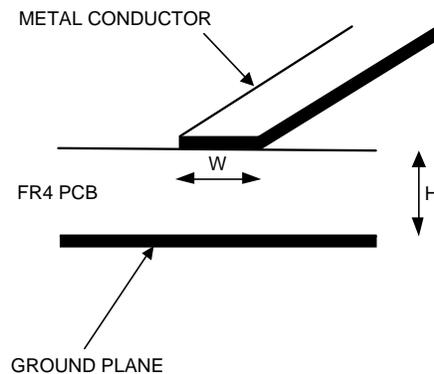
Layout Guidelines (continued)

Figure 83. Microstrip Configuration

A conductor (trace) is placed on the topside of a PCB. The bottom side of the PCB has a fully copper ground plane. The characteristic impedance of the microstrip transmission line is a function of the width W, height H, and the dielectric constant ε_r.

Characteristics such as height and the dielectric constant of the board have significant impact on transmission line dimensions. A 50-Ω transmission line may result in impractically wide traces. A typical 1.6-mm thick FR4 board results in a trace width of 2.9 mm, for instance. This is impractical for the LMV221 because the pad width of the 6-pin WSON package is 0.25 mm. The transmission line has to be tapered from 2.9 mm to 0.25 mm. Significant reflections and resonances in the frequency transfer function of the board may occur due to this tapering.

10.1.4 GCPW Configuration

A transmission line in a (grounded) coplanar waveguide (GCPW) configuration gives more flexibility in terms of trace width. The GCPW configuration is constructed with a conductor surrounded by ground at a certain distance, S, on the top side. Figure 84 shows a cross section of this configuration. The bottom side of the PCB is a ground plane. The ground planes on both sides of the PCB must be firmly connected to each other by multiple vias. The characteristic impedance of the transmission line is mainly determined by the width W and the distance S. In order to minimize reflections, the width W of the center trace must match the size of the package pad. The required value for the characteristic impedance can subsequently be realized by selection of the proper gap width S.
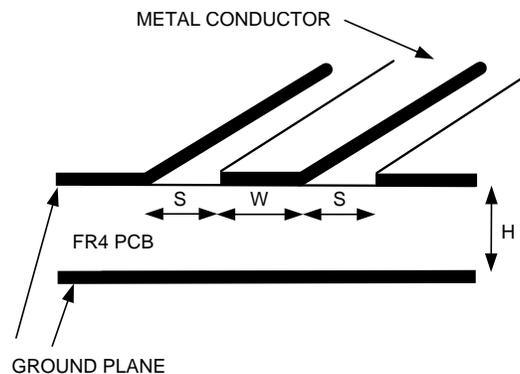

Figure 84. GCPW Configuration

Layout Guidelines (continued)

10.1.5 Reference (REF)

The REF pin can be used to compensate for temperature drift of the internal reference voltage as described in *Interface to the ADC*. The REF pin is directly connected to the inverting input of the transimpedance amplifier. Thus, RF signals and other spurious signals couple directly through to the output. Introduction of RF signals can be prevented by connecting a small capacitor between the REF pin and ground. The capacitor must be placed close to the REF pin as depicted in Figure 85.

10.1.6 Output (OUT)

The OUT pin is sensitive to crosstalk from the RF input, especially at high power levels. The ESD diode between OUT and VDD may rectify the crosstalk, but may add an unwanted inaccurate DC component to the output voltage.

The board layout must minimize crosstalk between the detectors input RFIN and the output of the detector. Using an additional capacitor connected between the output and the positive supply voltage (VDD pin) or GND can prevent this. For optimal performance this capacitor must be placed as close as possible to the OUT pin.
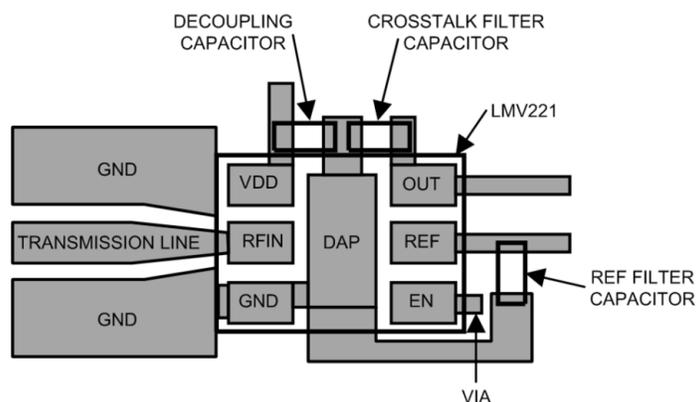
10.2 Layout Example

Figure 85. Recommended LMV221 Board Layout

11 Device and Documentation Support

11.1 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E™ Online Community *TI's Engineer-to-Engineer (E2E) Community.* Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

11.2 Trademarks

E2E is a trademark of Texas Instruments.
All other trademarks are the property of their respective owners.

11.3 Electrostatic Discharge Caution

These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

11.4 Glossary

SLYZ022 — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

42   *Submit Documentation Feedback*

Product Folder Links: *LMV221*

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
LMV221SD/NOPB	ACTIVE	WSON	NGF	6	1000	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 85	A96	Samples
LMV221SDX/NOPB	ACTIVE	WSON	NGF	6	4500	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 85	A96	Samples

(1) The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".
RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.
Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
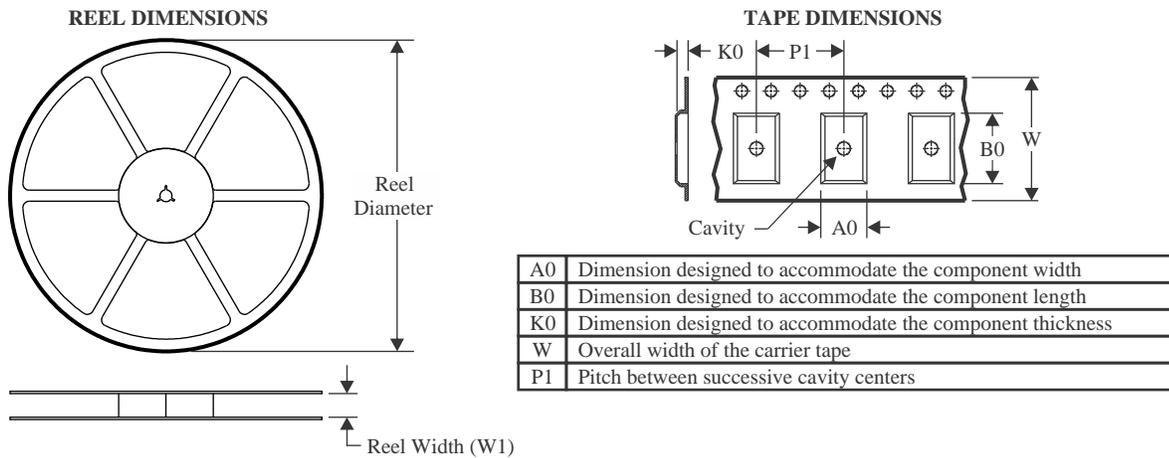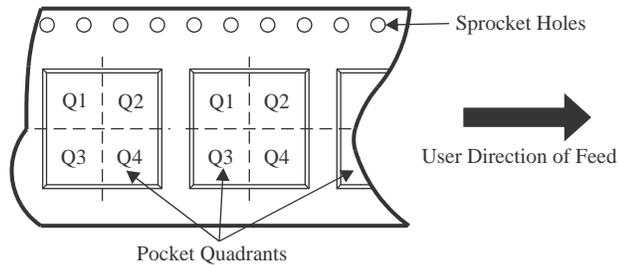
(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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TAPE AND REEL INFORMATION

REEL DIMENSIONS

Reel Diameter

Reel Width (W1)

TAPE DIMENSIONS

A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

Sprocket Holes

User Direction of Feed

Pocket Quadrants

*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
LMV221SD/NOPB	WSON	NGF	6	1000	178.0	12.4	2.8	2.5	1.0	8.0	12.0	Q1
LMV221SDX/NOPB	WSON	NGF	6	4500	330.0	12.4	2.8	2.5	1.0	8.0	12.0	Q1

TAPE AND REEL BOX DIMENSIONS
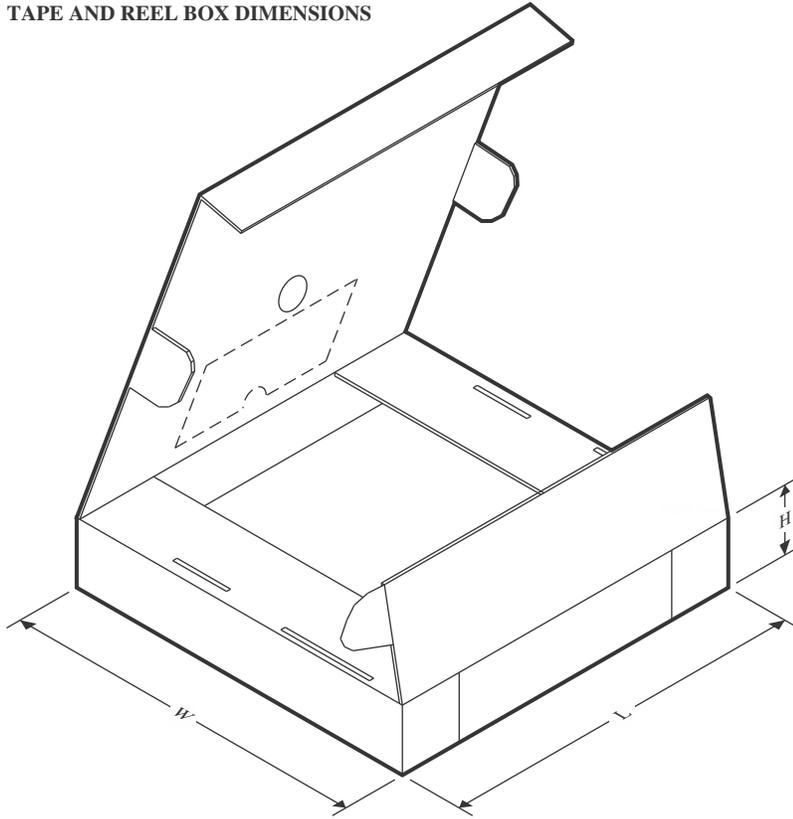
*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
LMV221SD/NOPB	WSON	NGF	6	1000	208.0	191.0	35.0
LMV221SDX/NOPB	WSON	NGF	6	4500	367.0	367.0	35.0

NGF0006A
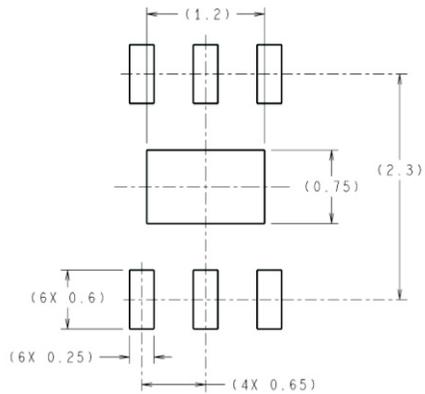
DIMENSIONS ARE IN MILLIMETERS
DIMENSIONS IN ( ) FOR REFERENCE ONLY
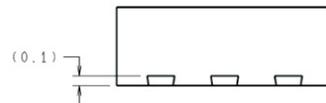
RECOMMENDED LAND PATTERN

PIN 1 INDEX AREA

PIN 1 ID
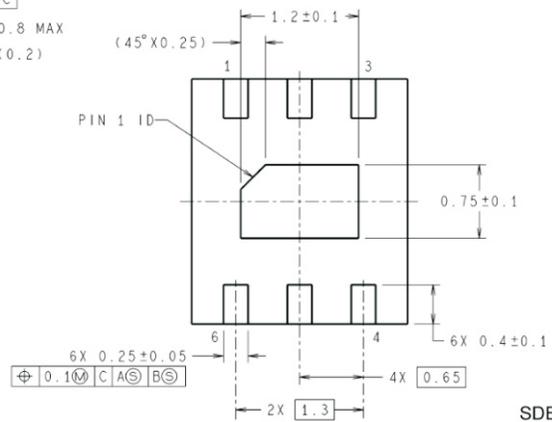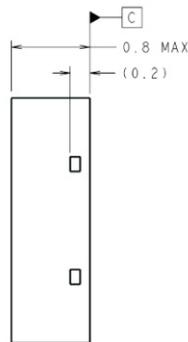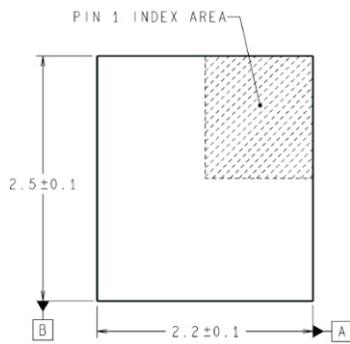
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